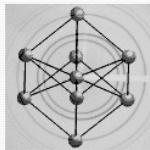


XRDUA – How to process (ID13) XRD imaging data

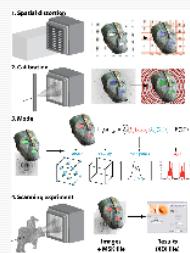
Frederik Vanmeert
03/12/2024



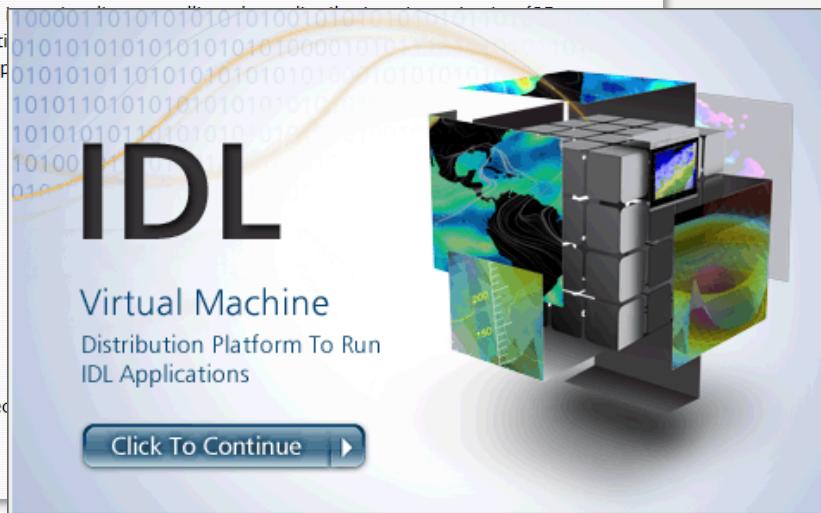
Latest XRDUA version: 7.7.1.1

[Overview](#) [What's new](#) [Download](#) [Source code](#) [Documentation](#) [Older versions](#) [Support](#)

XRDUA is a software package developed by the Antwerp X-ray Imaging/Instrumentation Laboratory (AXIL) at the University of Antwerp. Its main purpose is to automate the processing of two dimensional x-ray diffraction images from scanning (μ)XRPD or (μ)XRPD tomography. It accepts images from flat area detectors and allows correction, calibration and modeling (Rietveld, Pawley, Pattern Decomposition). The primary goal is to automatically extract structural information from a stack of images (scanning) or in a virtual cross section (tomography). It can also calculate the amount of material, structural properties and phase fractions. All results are visualized as well.



XRDUA mask file: contains corrected



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Installation/Starting up

Starting with XRDUA

1. Install IDL 8.3 or higher (no license required).
2. Download XRDUA from <https://xrdua.sourceforge.net/>
3. Unzip the xrdua_vx-x-x-x.zip package.
4. Double-click "xrdua.sav" (**Windows**) or type "idl -vm=xrdua.sav" in a shell (**Linux/MAC**).

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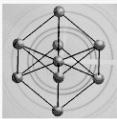
What to expect

- General introduction to XRDUA
- Most useful options to help you get from ID13 EDF integrated data to compound-specific distribution maps
- Some tips on how to use the software with example workflows
- (Strong) bias to pigments and paint samples

What not to expect

- Exhaustive overview and understanding of XRDUA
- Many useful/advanced options that we won't have time for
- Blindly follow to success

XRDUA
by Wout De Nolf

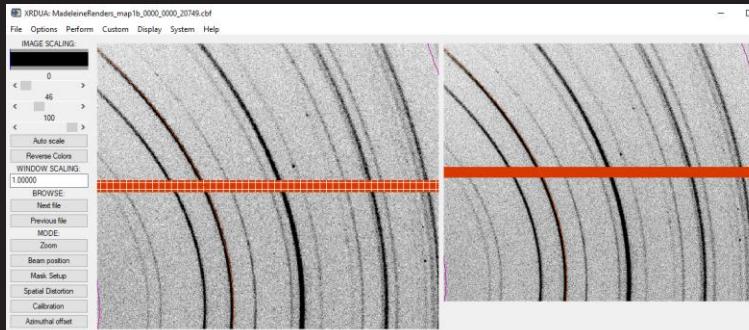


2D Powder-XRD Analysis



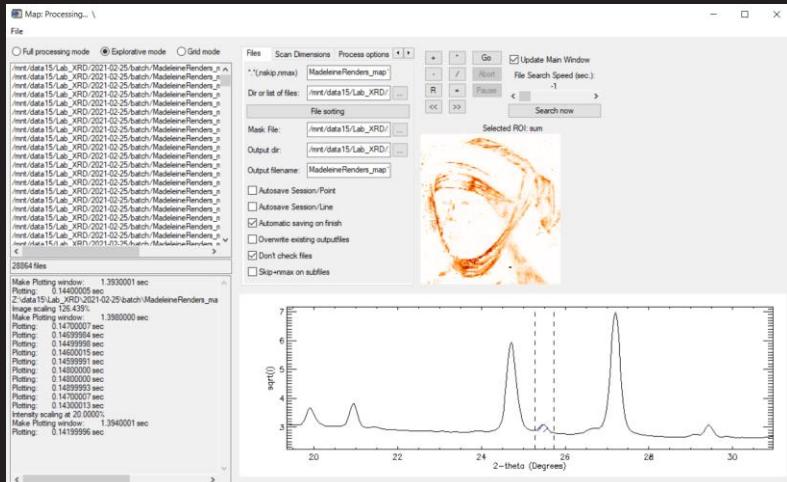
Dr. Wout de Nolf
(ESRF)

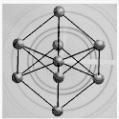
Universiteit
Antwerpen <https://xrdua.sourceforge.net>
<https://sourceforge.net/projects/xrdua/>



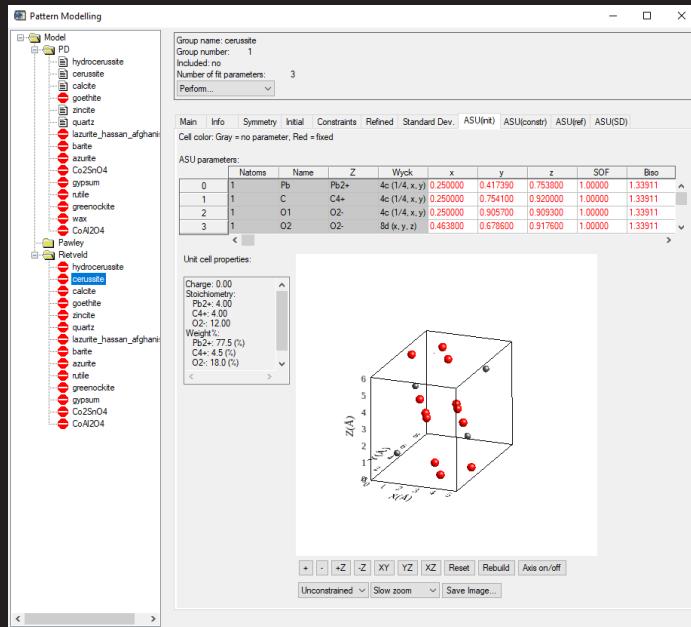
From raw diffraction data to phase distributions

- 2D diffraction image corrections
 - Spatial distortion / Flat field / Saturation / Masking / ...
- Calibration
- (batch) Azimuthal integration
 - Mean / median / ...
- ROI imaging
- Reference matching
- Autonomous whole pattern fitting
 - Rietveld, Pawley, PD
- Visualization (based on scaling factors, weight fractions, ...)
- ...



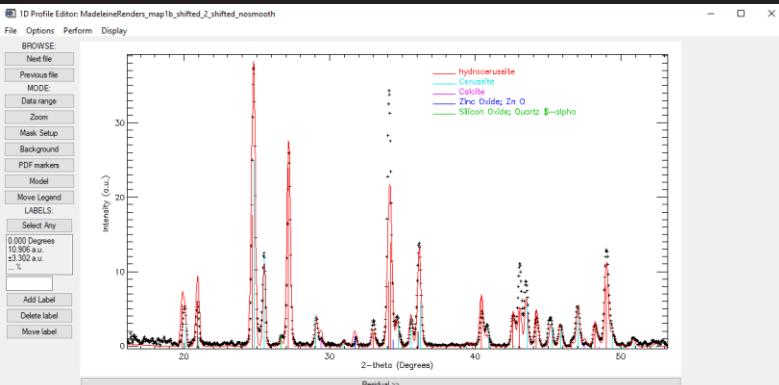


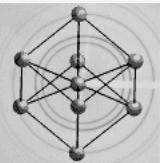
Dr. Wout de Nolf
(ESRF)



From raw diffraction data to phase distributions

- 2D diffraction image corrections
 - Spatial distortion / Flat field / Saturation / Masking / ...
- Calibration
- (batch) Azimuthal integration
 - Mean / median / ...
- ROI imaging
- Reference matching
- Autonomous whole pattern fitting
 - Rietveld, Pawley, PD
- Visualization (based on scaling factors, weight fractions, ...)
- ...





Latest XRDUA version: 7.7.1.1

[Overview](#) [What's new](#) [Download](#) [Source code](#) [Documentation](#) [Older versions](#) [Support](#)

The XRDUA Documentation Series contains:

- Part1 (**obsolete: needs updating!**): Reference Manual
- Part2: Tutorial manuscript with example data

A more elaborate tutorial with manual and example data is available on the XRDUA website:
[XRDUA Distribution Page](#)

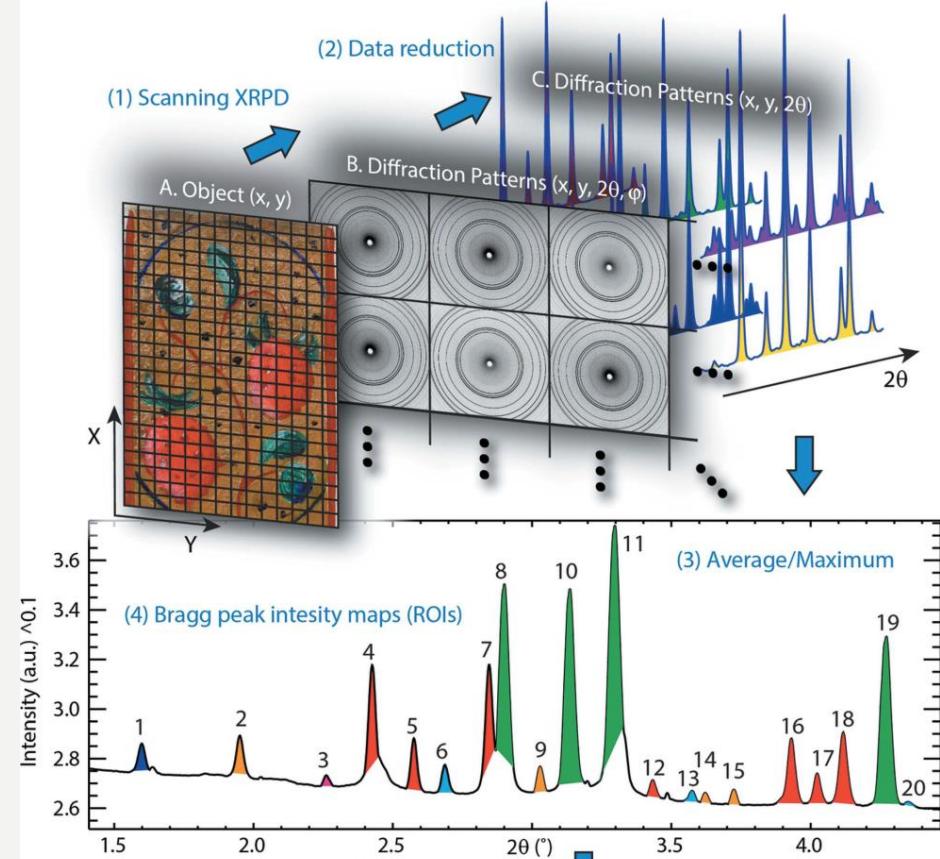
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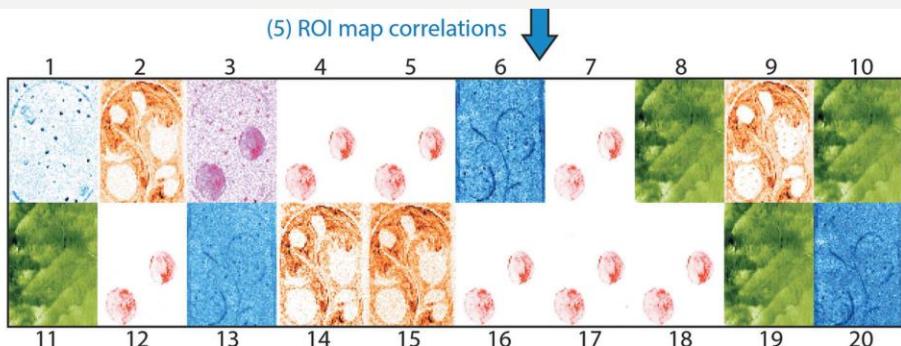
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Official XRDUA tutorial

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De Nolf, W., et al. (2014). "XRDUA: crystalline phase distribution maps by two-dimensional scanning and tomographic (micro) X-ray powder diffraction." Journal of Applied Crystallography 47(3): 1107-1117.

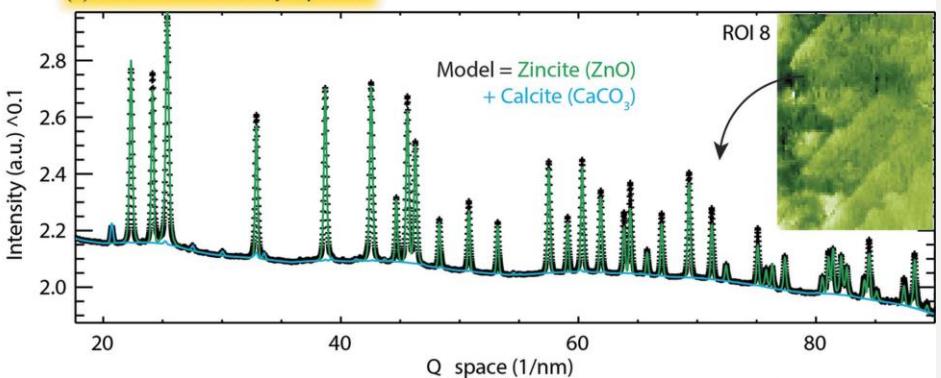


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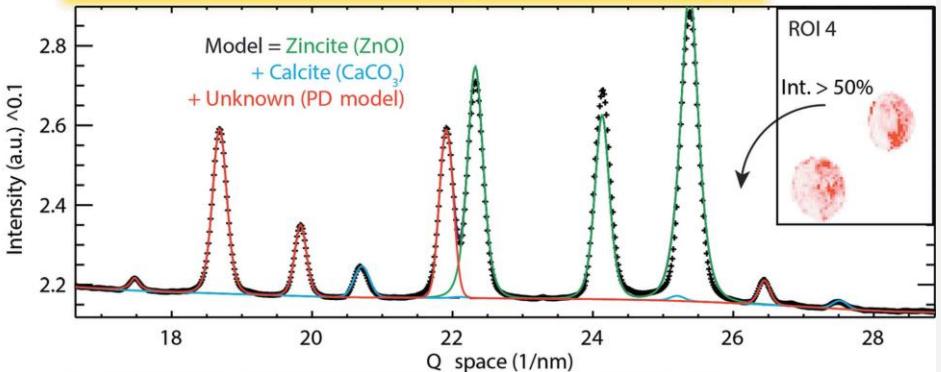
XRDUA Workflow

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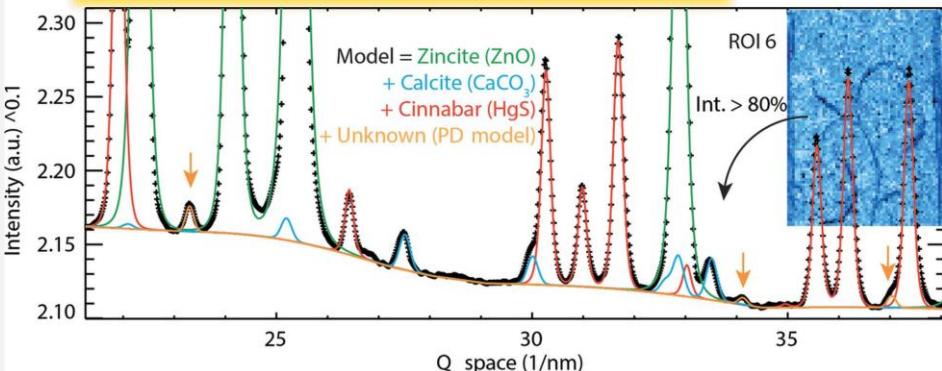
(a) Identification of major phases



(b) Identification based on unindexed Bragg peaks from the strawberry area



(c) Identification based on unindexed Bragg from the red markup lines



(d) Batch fitting with complete model

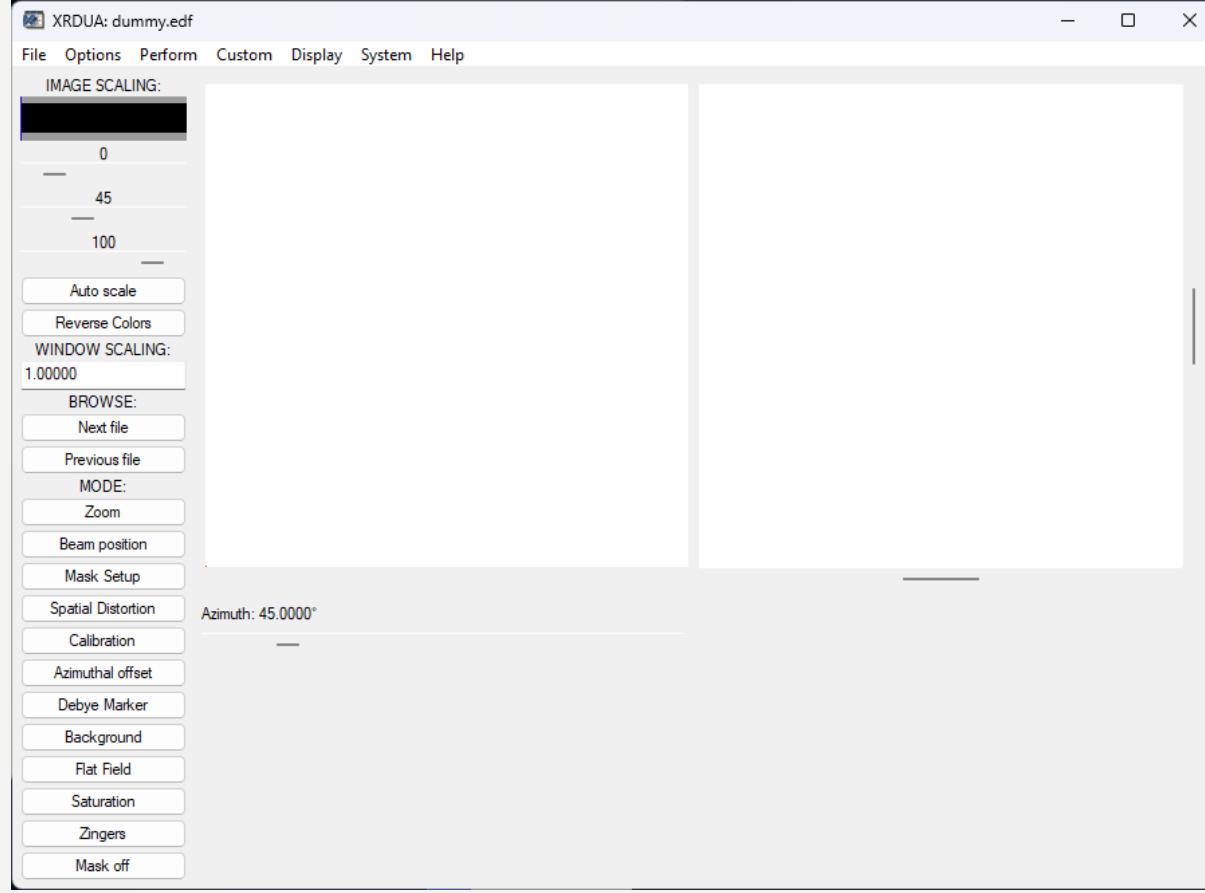


De Nolf, W., et al. (2014). "XRDUA: crystalline phase distribution maps by two-dimensional scanning and tomographic (micro) X-ray powder diffraction." Journal of Applied Crystallography 47(3): 1107-1117.

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XRDUA Workflow

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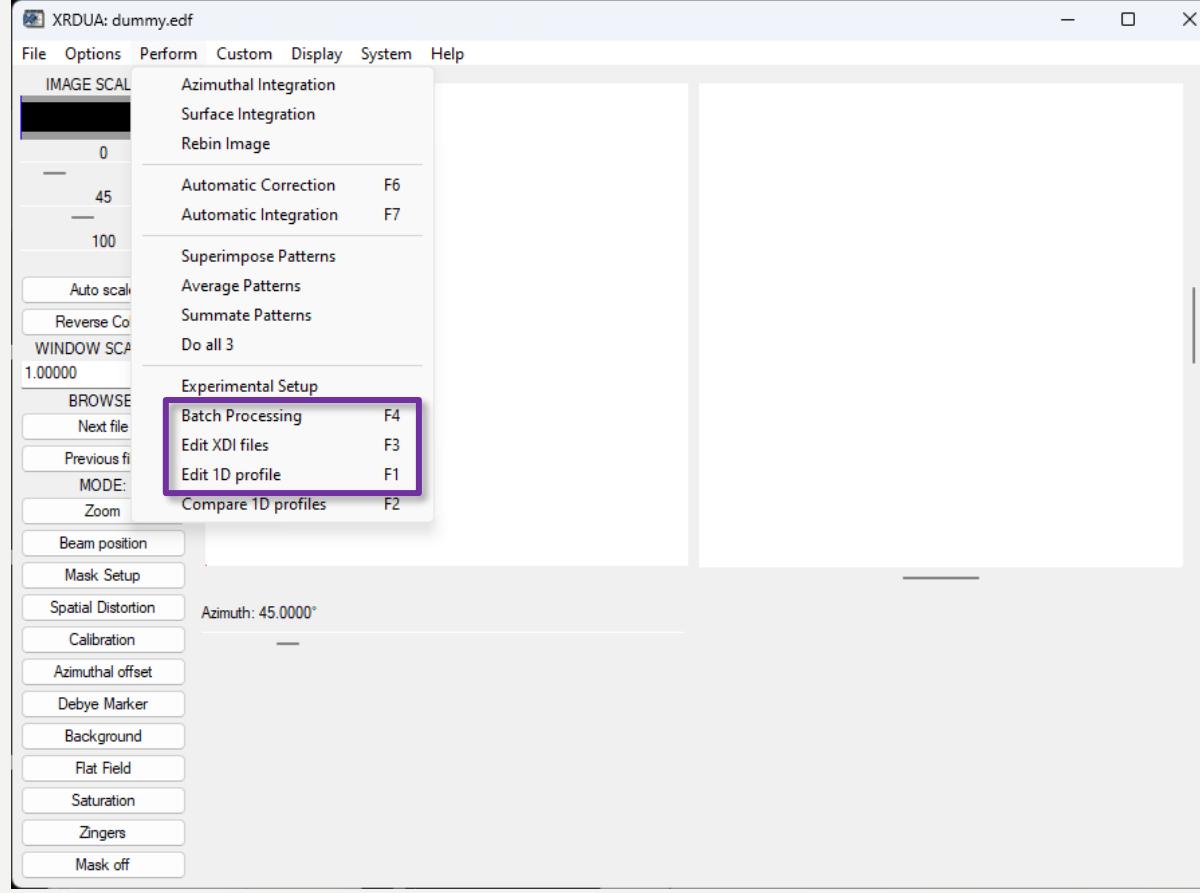
XRDUA 2D

- visualizing 2D patterns
- 2D pattern corrections
- geometry calibration
- defining settings for azimuthal integration
- ...

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Main windows: **XRDUA 2D**

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XRDUA 2D

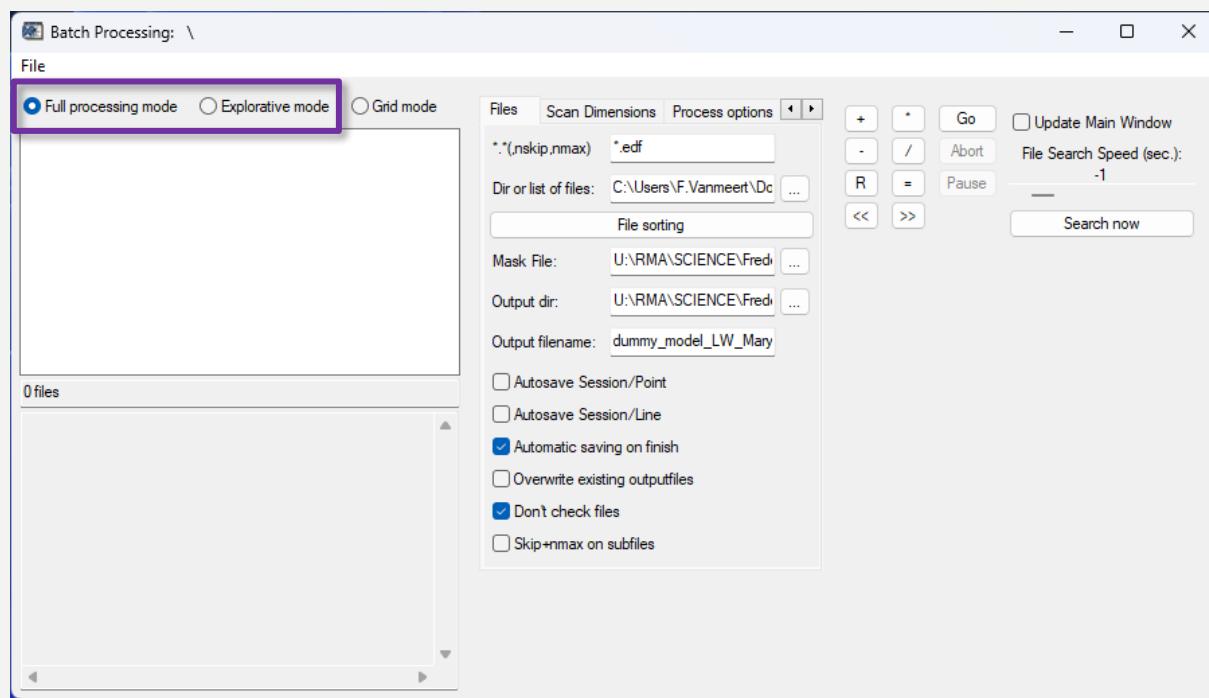
Perform ->

- *Batch Processing*
 - Perform batch processes
 - 2D -> 1D
 - 1D -> distribution maps
- *Edit 1D profile*
 - 1D diffractograms
 - Fitting model
- *Edit XDI files*
 - Results

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Main windows: **XRDUA 2D**

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XRDUA BP

- *Explorative Mode*

- Perform batch azimuthal integration (2D to 1D)
- Explore data
- ROI imaging
- Extract 1D diffractograms

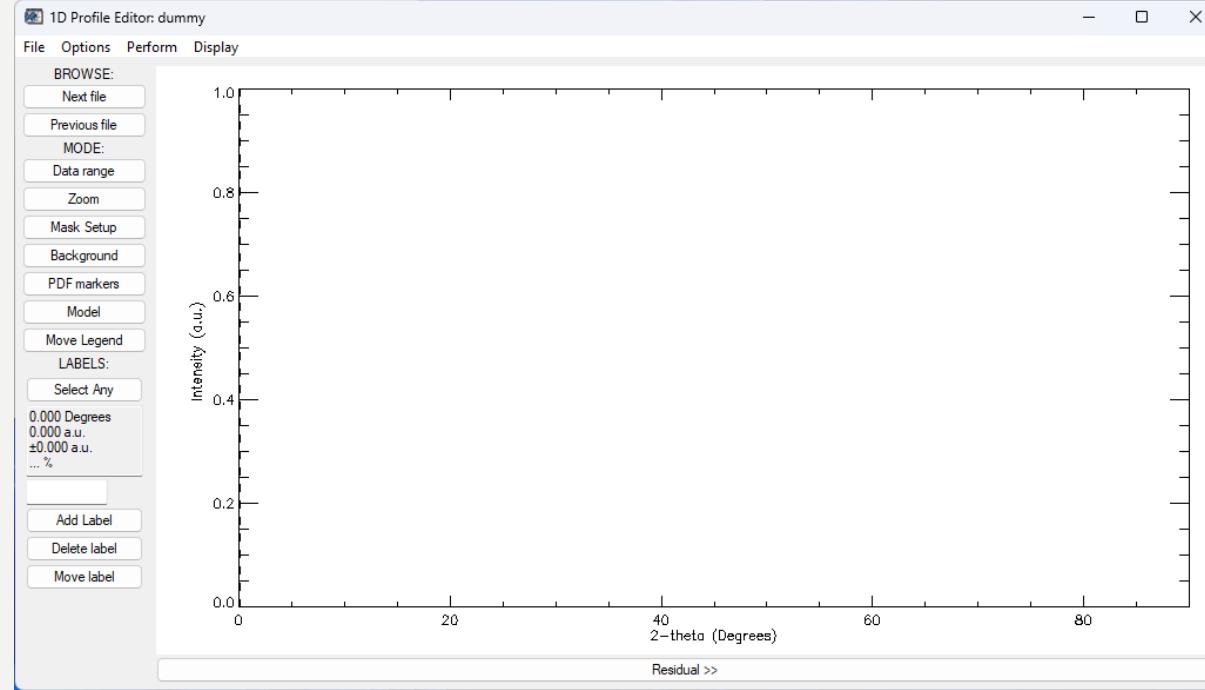
- *Full Processing Mode*

- Perform batch fitting (1D to distribution maps)

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Main windows: **XRDUA BP**

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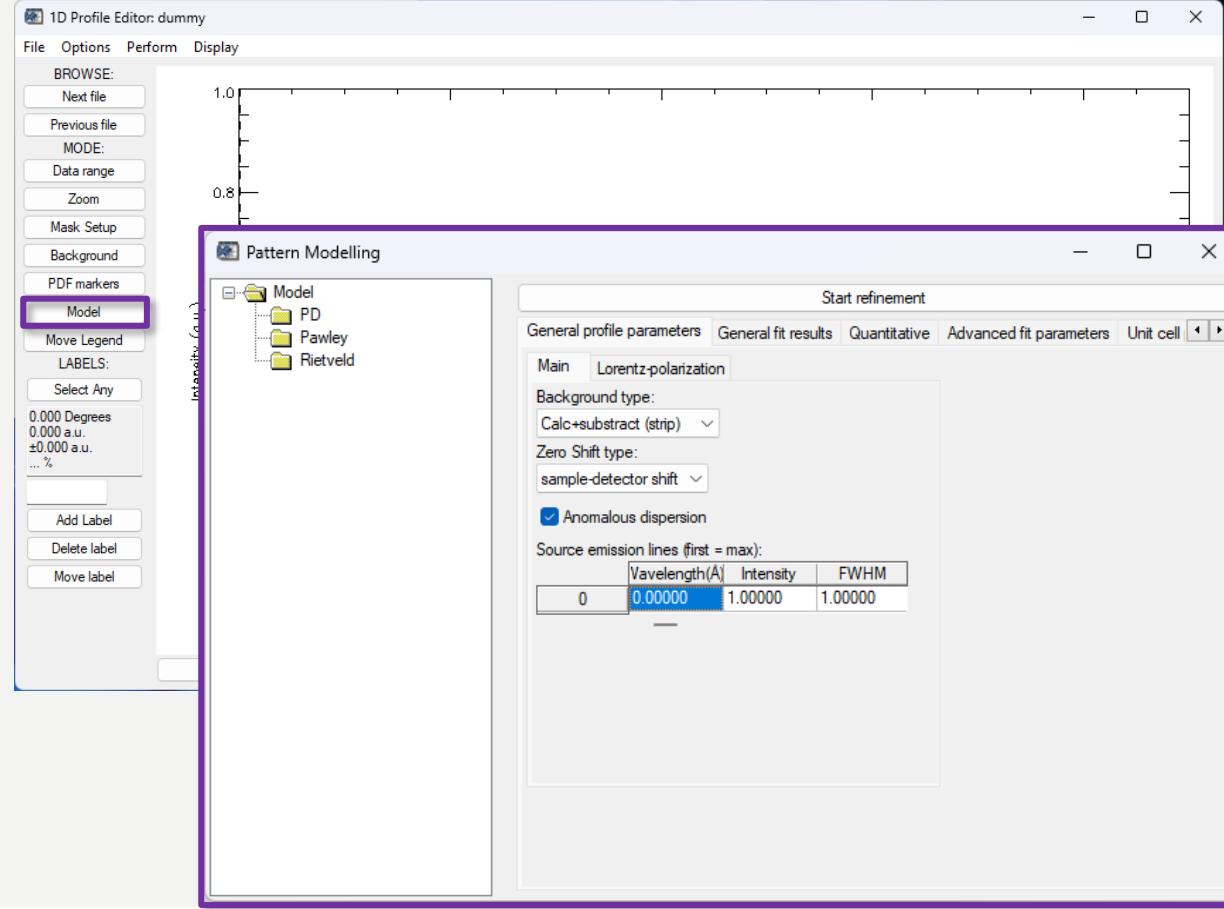
XRDUA 1D

- *Main Window*
 - Shows 1D diffractograms
 - Background subtraction
 - Overlay PDFs
 - ...
- *Model*
 - Create fit models

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Main windows: **XRDUA 1D**

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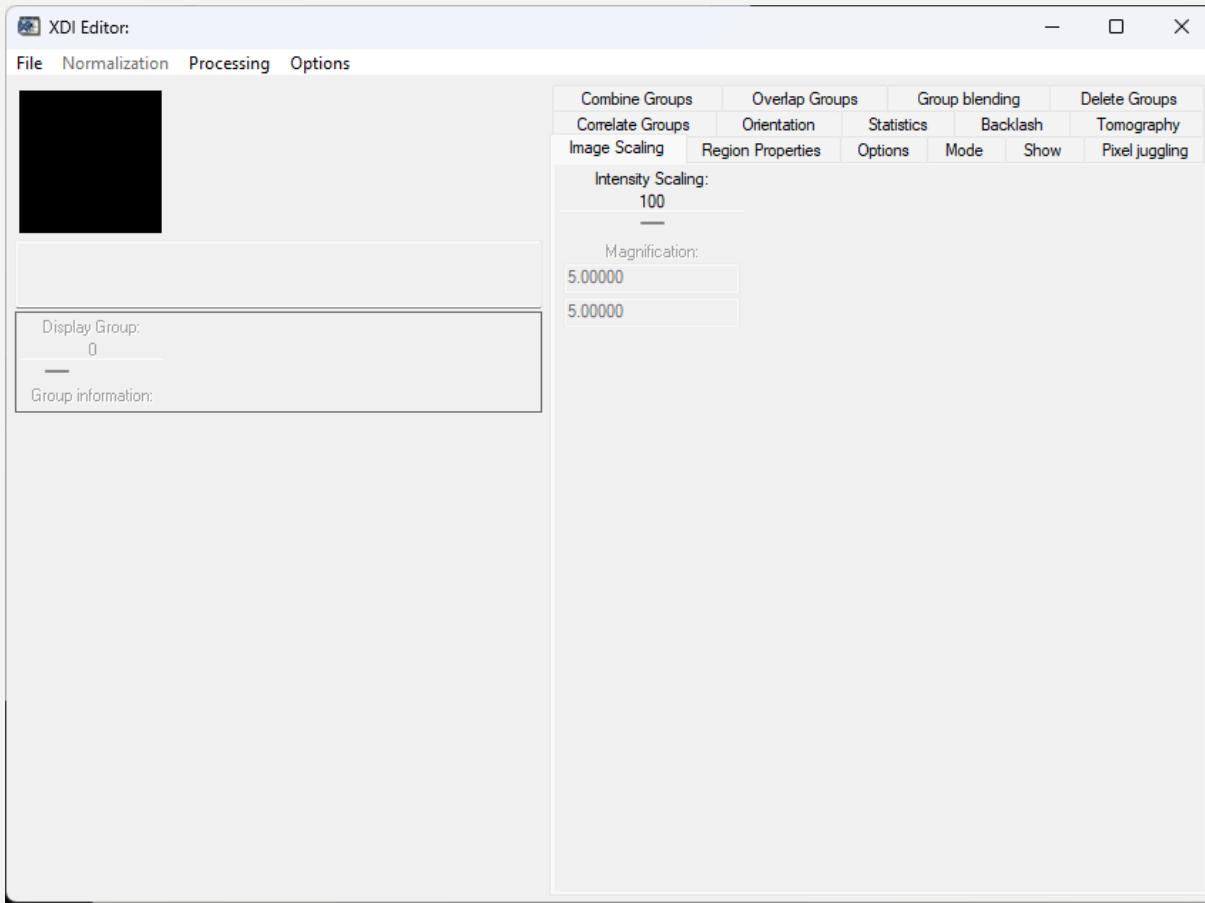
XRDUA 1D

- *Main Window*
 - Shows 1D diffractograms
 - Background subtraction
 - Overlay PDFs
 - ...
- *Model*
 - Create fit models

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Main windows: **Modelling**

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XRDUA XDI

- *Results (groups)*
 - (Intensity) Scaling
 - Edit/combine results
 - Resize results
 - ...
- *Tomography*
 - Single slice tomography reconstruction

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Main windows: **XRDUA XDI**

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Batch Processing: I

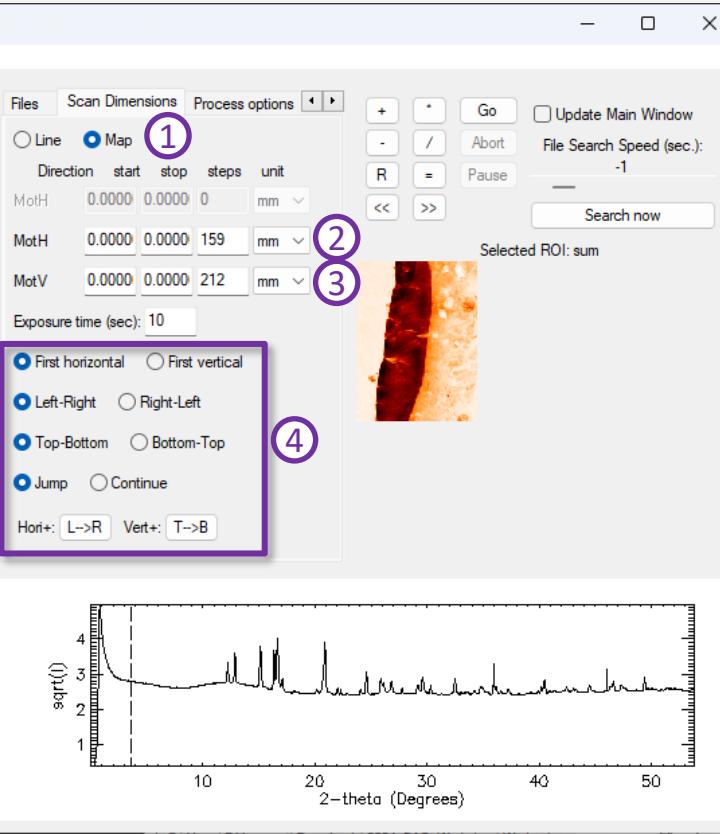
File

Full processing mode Explorative mode Grid mode

34080 files (progress: 34080/34080)

Plotting: 0.93400002 sec
Save and plot results: 0.93999982 sec
Total file time: 14.439000 sec
Number of patterns left: 0
Estimated time left: 0.0000000 sec

```
Saving results ...
C:\Users\F.Vanmeert\Downloads\2024_BAG_Workshop\Work:
Partial results: Saved
C:\Users\F.Vanmeert\Downloads\2024_BAG_Workshop\Work:
Total time: 22.383000 sec
-----FINISHED-----
C:\Users\F.Vanmeert\Downloads\2024_BAG_Workshop\Work:
```



XRDUA BP

Scan Dimensions

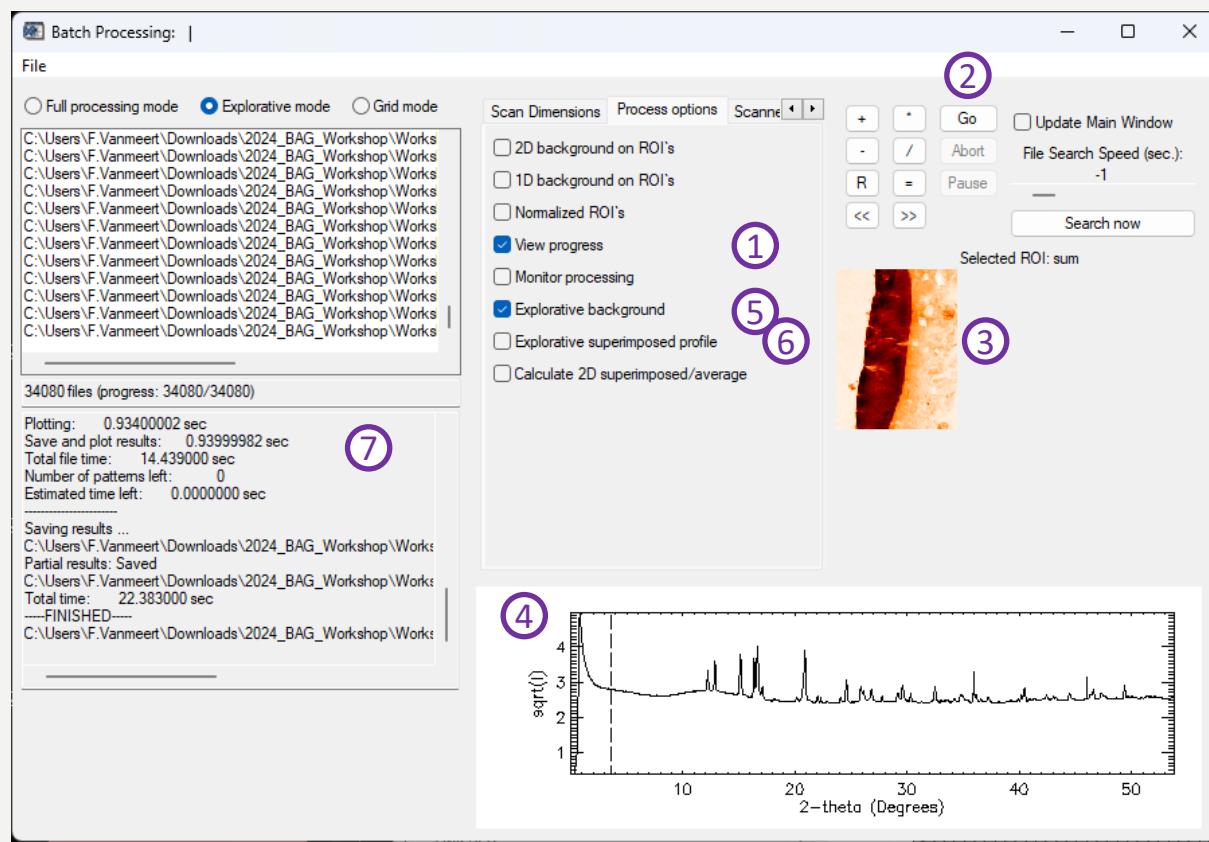
1. Map
 2. MotH steps: #pixels - 1
 3. MotV steps: #pixels - 1
 4. Options to change the orientation of the map



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1. Loading ID13 EDF data

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XRDUA BP

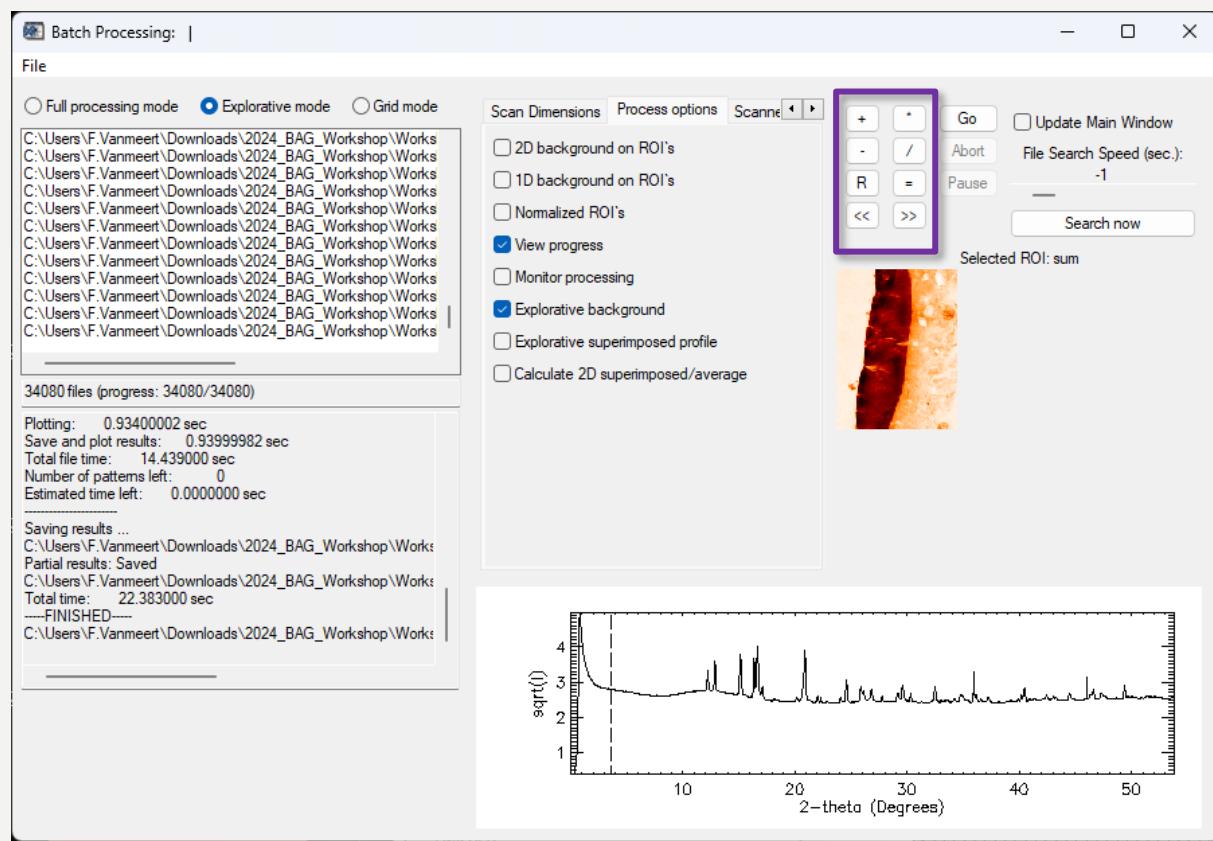
Process options

1. View progress to view the ROI image
2. Go!
3. ROI Image
4. Average (default) profile of the entire map
5. Explorative background applies a linear background under the ROI
6. Show superimposed profile instead of average profile
7. Some useful output
 - BP session, 1D tiff and XDI are automatically saved

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1. Loading ID13 EDF data

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XRDUA BP

ROI image visualization

- + : increase ROI image size
 - - : decrease ROI image size
 - R : reset ROI image size
 - * : decrease contrast
 - / : increase contrast
 - = : set value for contrast based on max. intensity

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2. Exploring Data

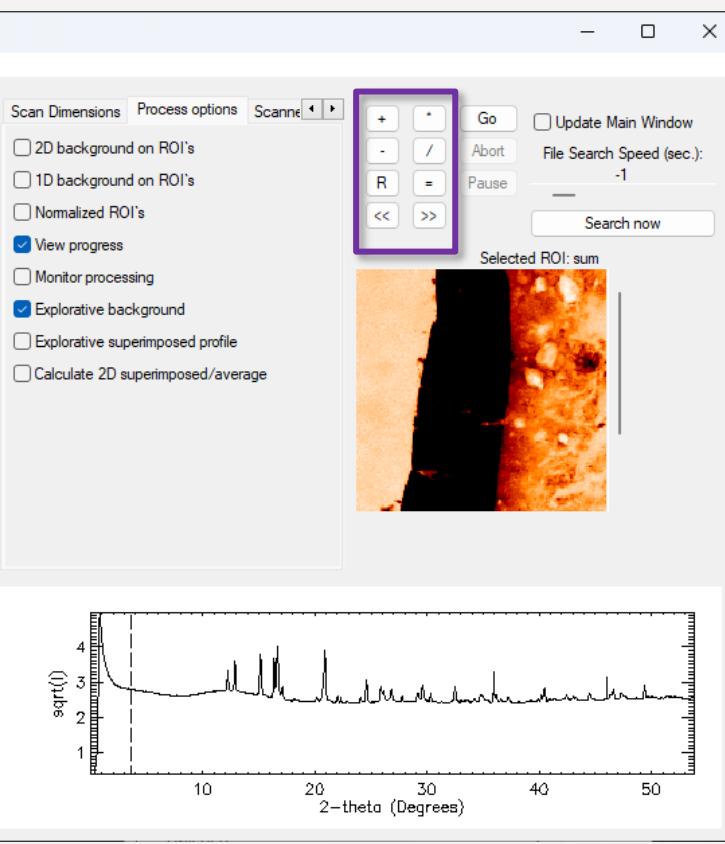
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Full processing mode Explorative mode Grid mode

```
C:\Users\F.Vanmeert\Downloads\2024_BAG_Workshop\Works
```

34080 files (progress: 34080/34080)

Plotting: 0.87400007 sec
 Image scaling 67.5000%
 Make Plotting window: 3.204000 sec
 Plotting: 0.85999990 sec
 Image scaling 81.0000%
 Make Plotting window: 2.743000 sec
 Plotting: 0.86500001 sec
 Image scaling 97.2000%
 Make Plotting window: 2.7539999 sec
 Plotting: 0.83799982 sec
 Image scaling 116.640%
 Make Plotting window: 3.006000 sec
 Plotting: 0.88700008 sec



XRDUA BP

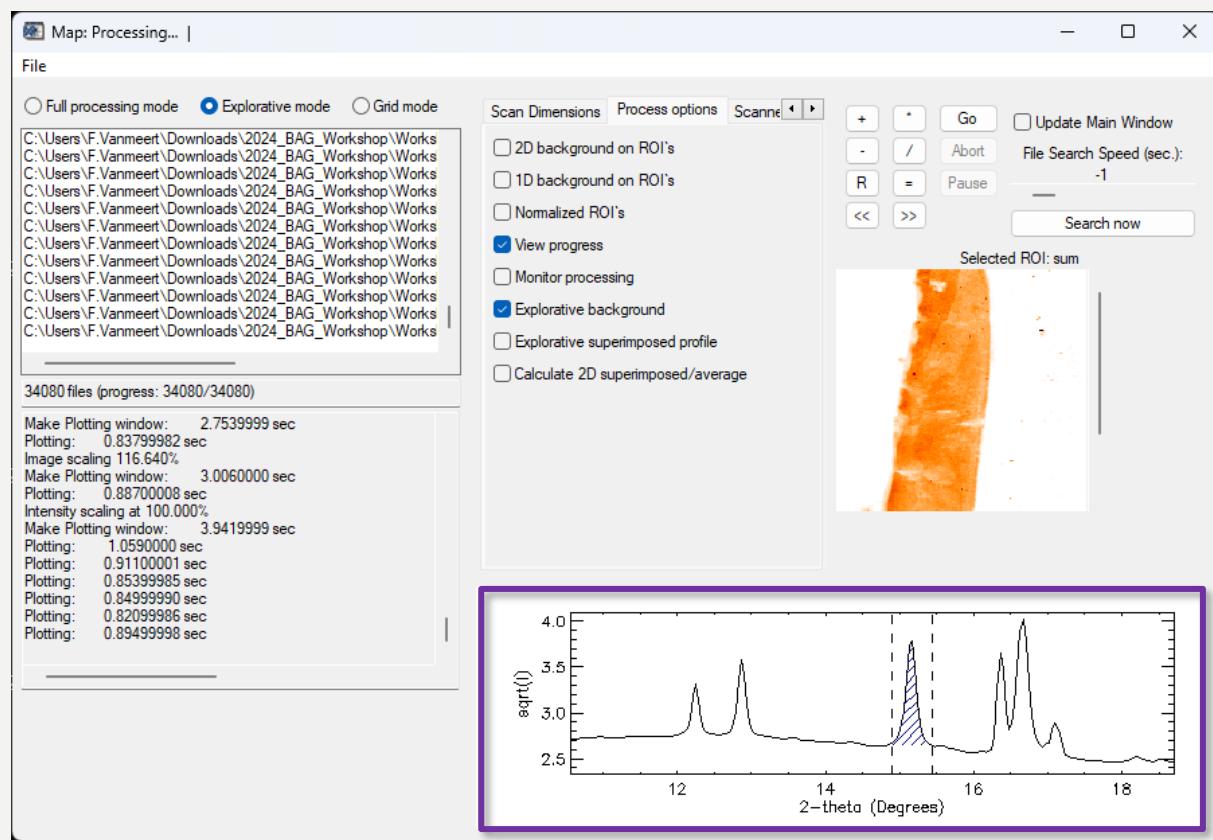
ROI image visualization

- + : increase ROI image size
- - : decrease ROI image size
- R : reset ROI image size
- * : decrease contrast
- / : increase contrast
- = : set value for contrast based on max. intensity

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2. Exploring Data

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XRDUA BP

1D profile options

- **Right-click and hold** : zoom in
 - **Single right-click** : zoom out to original
 - **Left-click and hold** : select ROI
 - When a ROI is selected, you can use the left/right arrows (for small jumps) and the up/down arrows (for large jumps) to move the ROI over the 1D profile

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2. Exploring Data

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Full processing mode Explorative mode Grid mode

```
C:\Users\F.Vanmeert\Downloads\2024_BAG_Workshop\Works
```

34080 files (progress: 34080/34080)

Make Plotting window: 2.7539999 sec

Plotting: 0.83799982 sec

Image scaling 116.640%

Make Plotting window: 3.0060000 sec

Plotting: 0.88700008 sec

Intensity scaling at 100.000%

Make Plotting window: 3.9419999 sec

Plotting: 1.0590000 sec

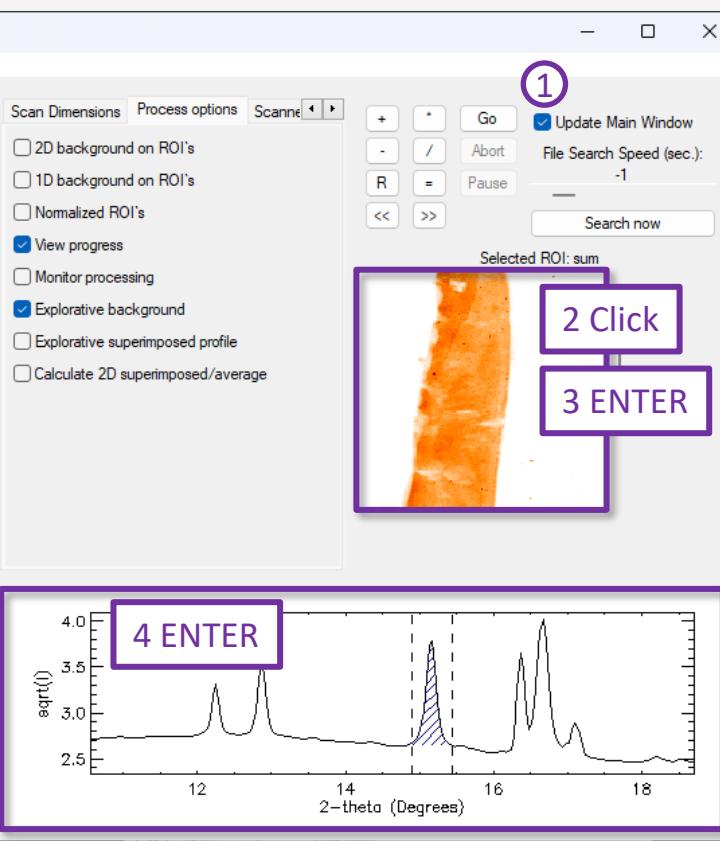
Plotting: 0.91100001 sec

Plotting: 0.85399985 sec

Plotting: 0.84999990 sec

Plotting: 0.82099986 sec

Plotting: 0.89499998 sec



XRDUA BP

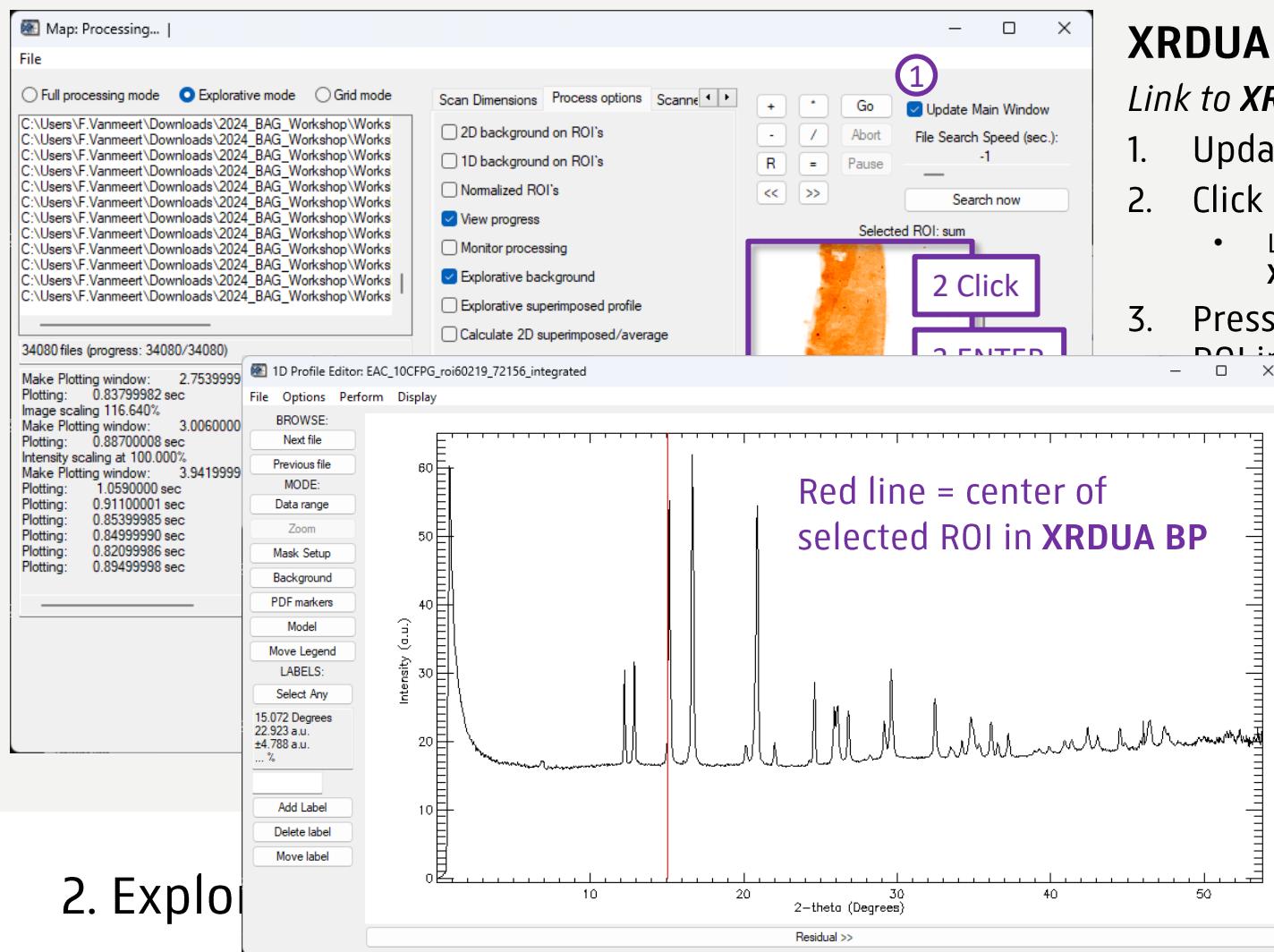
[Link to XRDUA 1D](#)

1. Update Main Window
2. Click pixel in ROI image
 - Loads 1D profile of that pixel to XRDUA 1D
3. Press ENTER when cursor is in ROI image
 - Loads averaged (or superimposed) 1D profile based on current ROI intensity in XRDUA 1D
4. Press ENTER when cursor is in 1D profile
 - Loads averaged (or superimposed) 1D profile in XRDUA 1D

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2. Exploring Data – Extracting 1D profiles

Rijks Museum



XRDUA BP

Link to XRDUA 1D

1. Update Main Window
 2. Click pixel in ROI image
 - Loads 1D profile of that pixel to **XRDUA 1D**
 3. Press ENTER when cursor is in **ROI image**

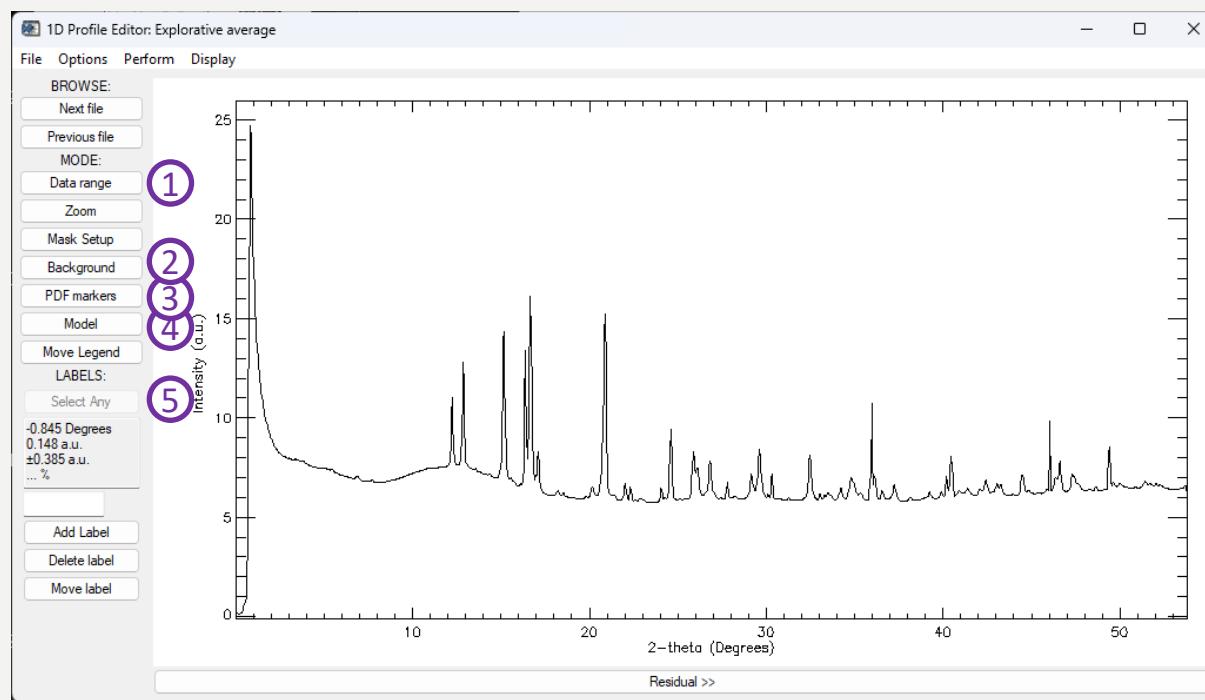
ads averaged (or superimposed)
profile based on current ROI
intensity in **XRDUA 1D**

ENTER when cursor is in file

ads averaged (or superimposed) profile in **XRDUA 1D**

2. Exploratory Data Analysis

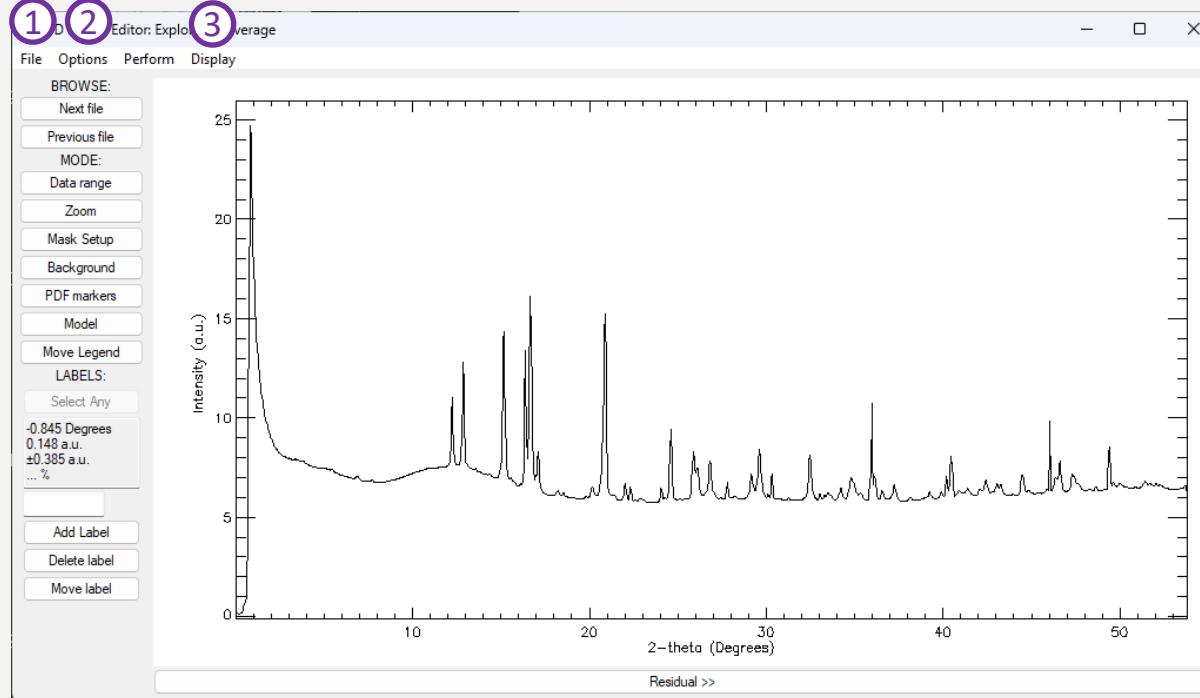
RIJKS MUSEUM



XRDUA 1D

Some main options

1. Set the data range to include in fit model
2. Apply background corrections
3. Go through PDF files
4. Open the Model window
5. Move the red line from **XRDUA BP**



XRDUA 1D

Some main options

1. File

- Save/Load Mask (contains experimental parameters and fit model)
- Load (Multiple) PDF

2. Options

- X: Y: (Change axis options)
- Parameters (edit geometry parameters)

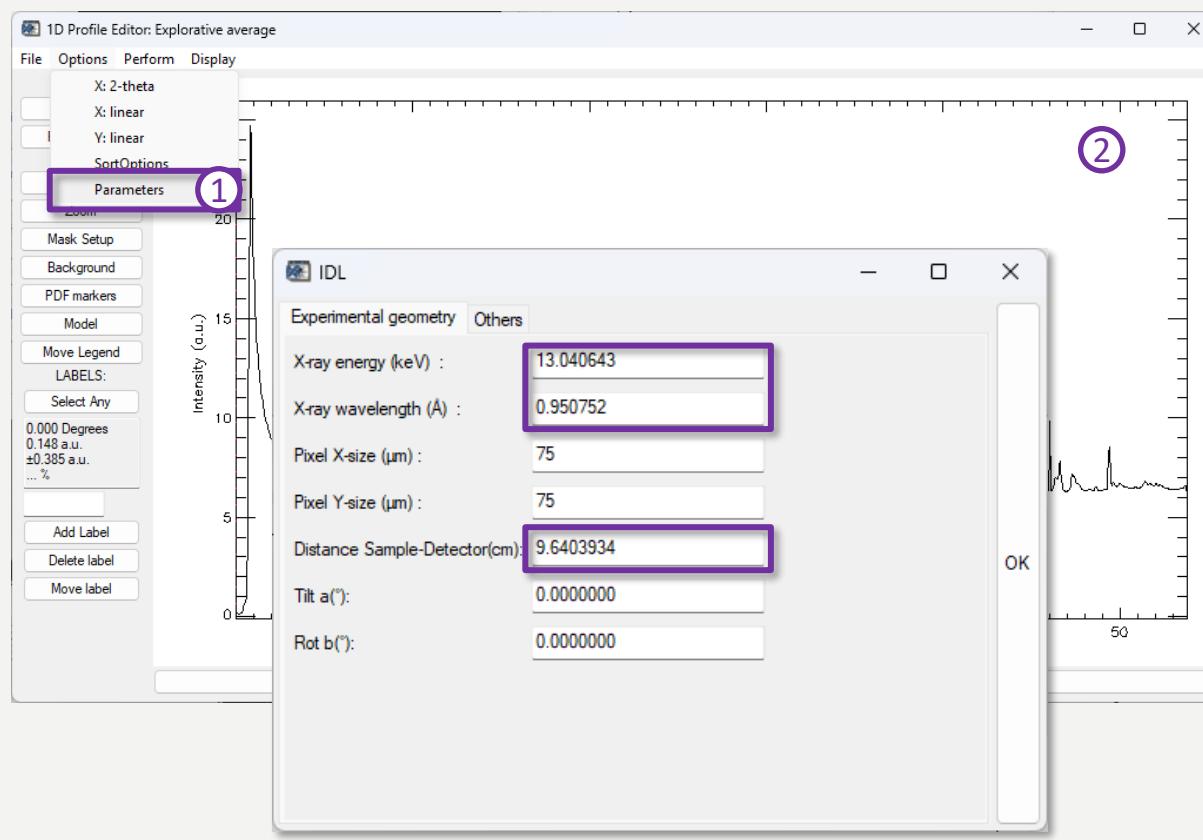
3. Display

- Fit Total (Change visualization of fit)
- Show Peaks (Show initial estimates of the model)
- View PDF (Enable/Disable PDF and scale PDF)

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XRDUA 1D

Rijksmuseum



XRDUA 1D

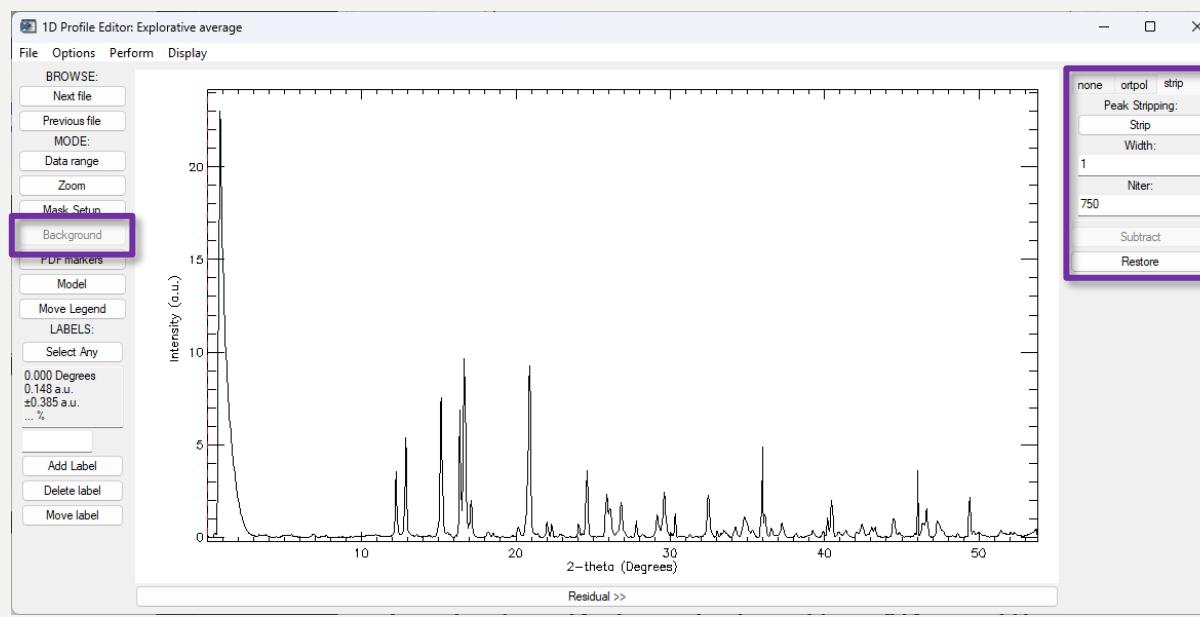
1. Set Experimental Geometry

- X-ray Energy/Wavelength
- Distance Sample-Detector

These values are specific for each beamtime. Check the poni file of that beamtime for these values.

2. Reload 1D profile from XRDUA BP

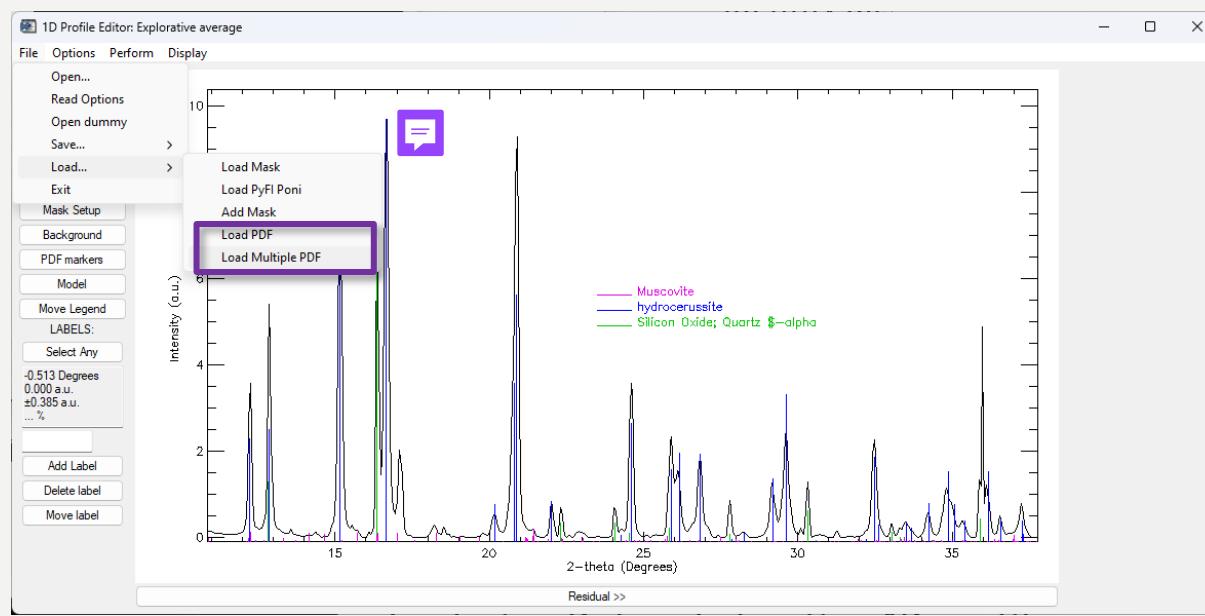
This is necessary the first time that you fill in the values of step 1 or load these values from an existing mask file.



XRDUA 1D

Background Subtraction

- The Strip background usually works well. Set the Niter value so that it follows the background without cutting away intensity from the diffraction peaks.
- The background correction is shown as a dashed green line
- Display -> Hide Background
 - To remove the dashed green line



XRDUA 1D

Identifying compounds

- Load (Multiple) PDF
- Use prior knowledge of your samples

PDF

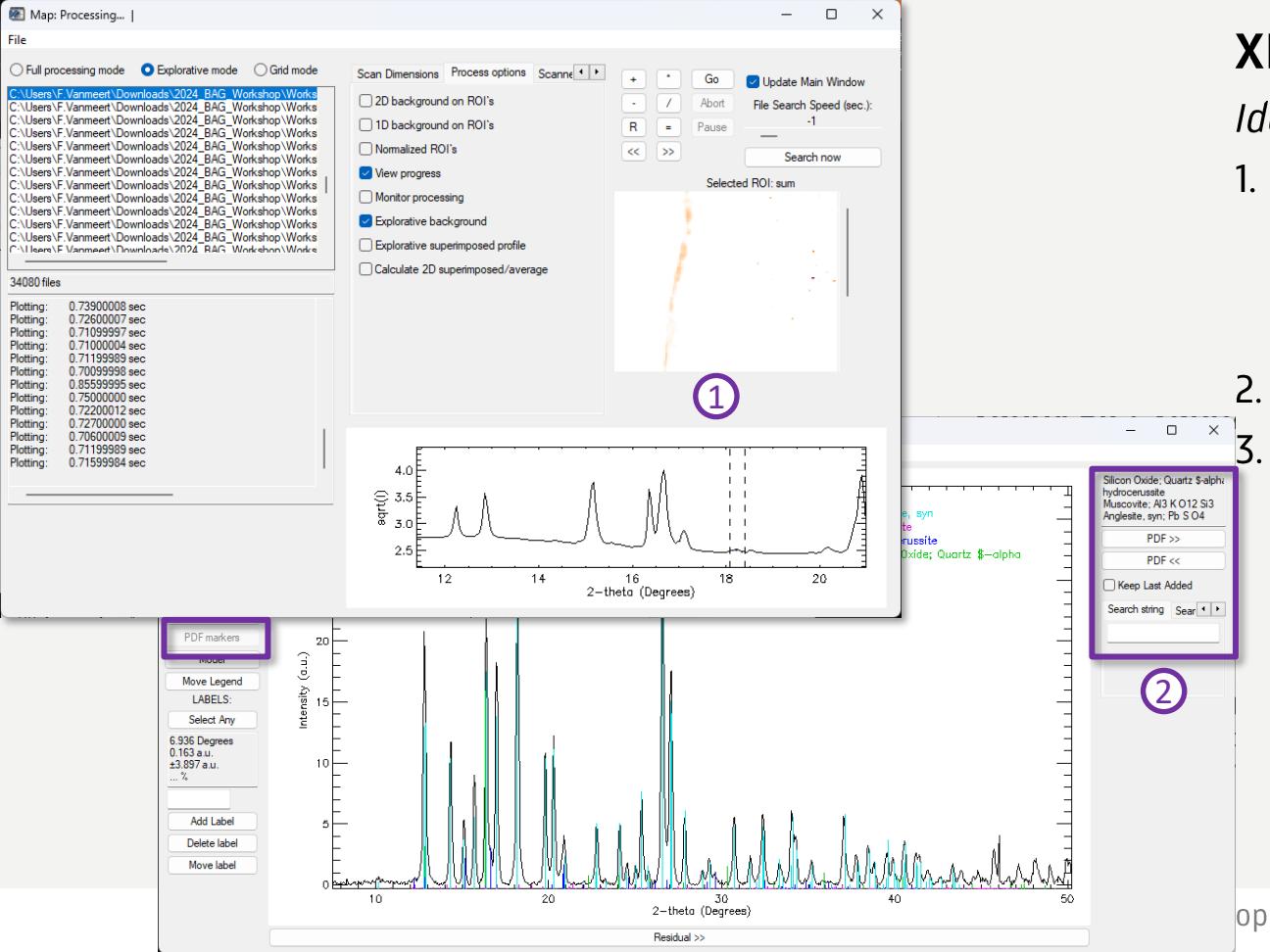
Powder diffraction files

These files are obtained through other software, such as Match! and various extensions are possible. It is also possible to create these within the XRDUA Model window (saved as .pdd).

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3. Identifying compounds

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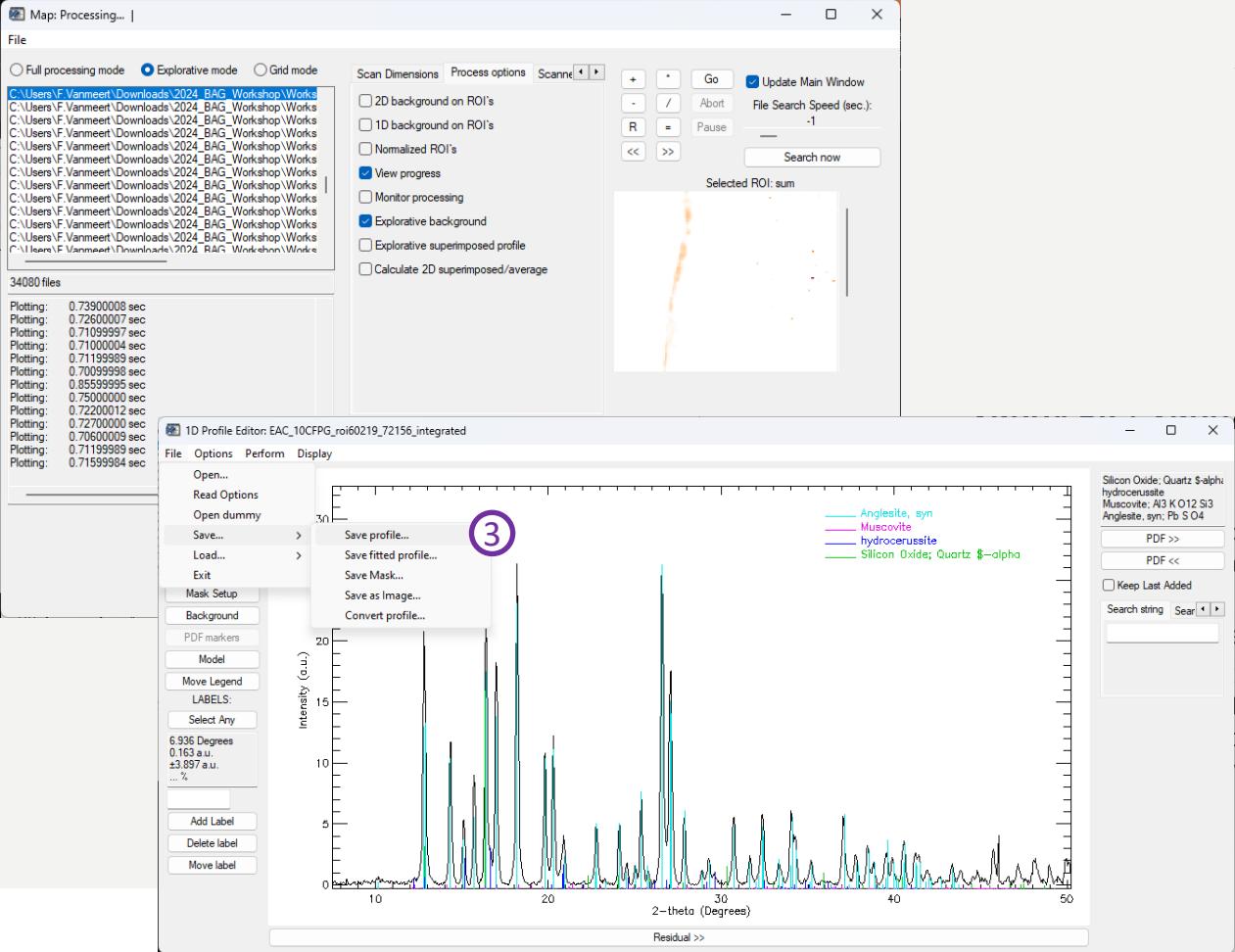
XRDUA BP + XRDUA 1D

Identifying compounds

1. Use ROI tool in **XRDUA BP** to select unidentified peaks and obtain a good 1D profile for identification
 2. Check with available PDF
 3. If no PDF file can explain the signal(s), save the 1D profile in **XRDUA 1D** and use dedicated search-match software (Match!, QualX2, ...).

3. Identifying compounds

op



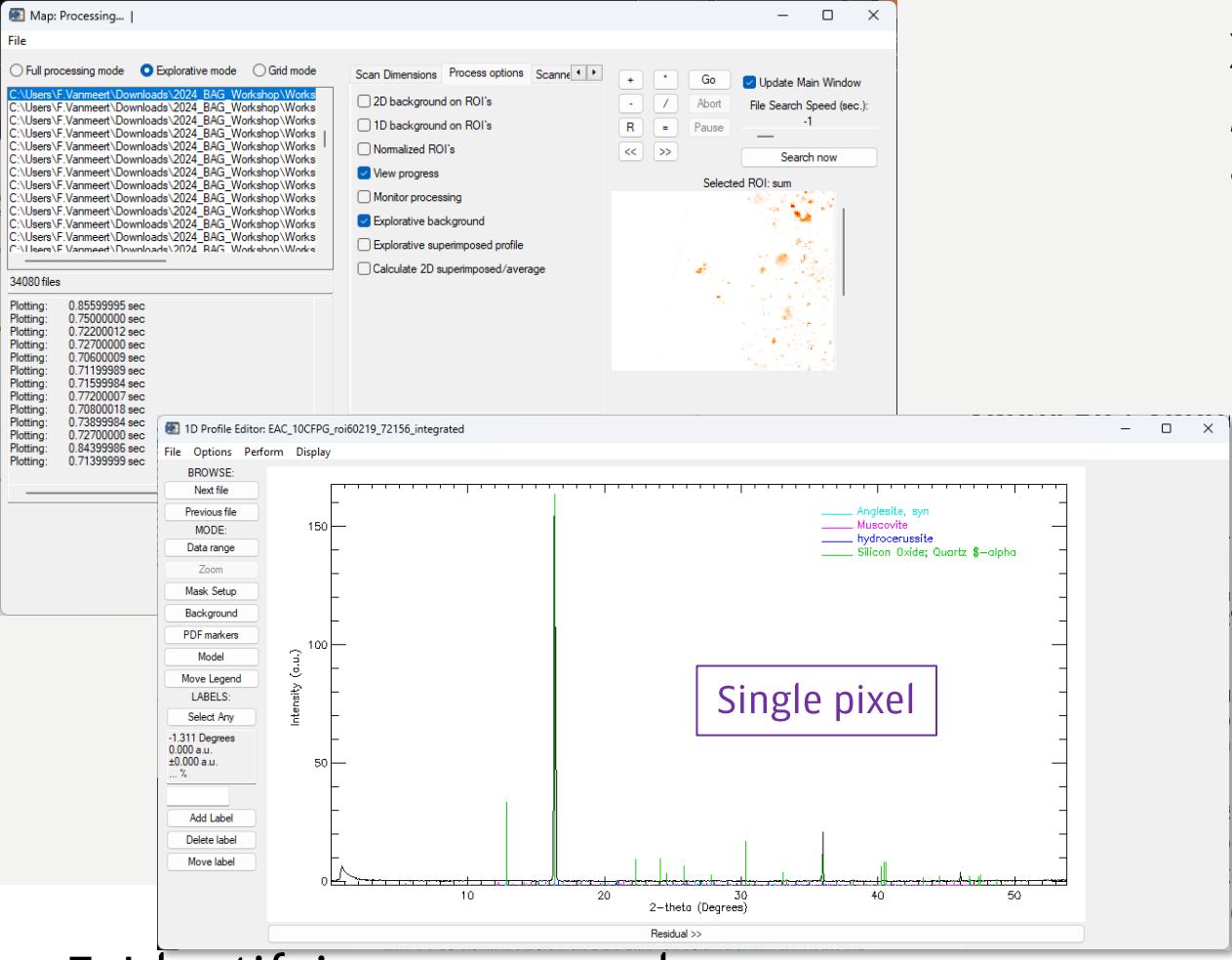
XRDUA BP + XRDUA 1D

Identifying compounds

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3. Identifying compounds

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3. Identifying compounds

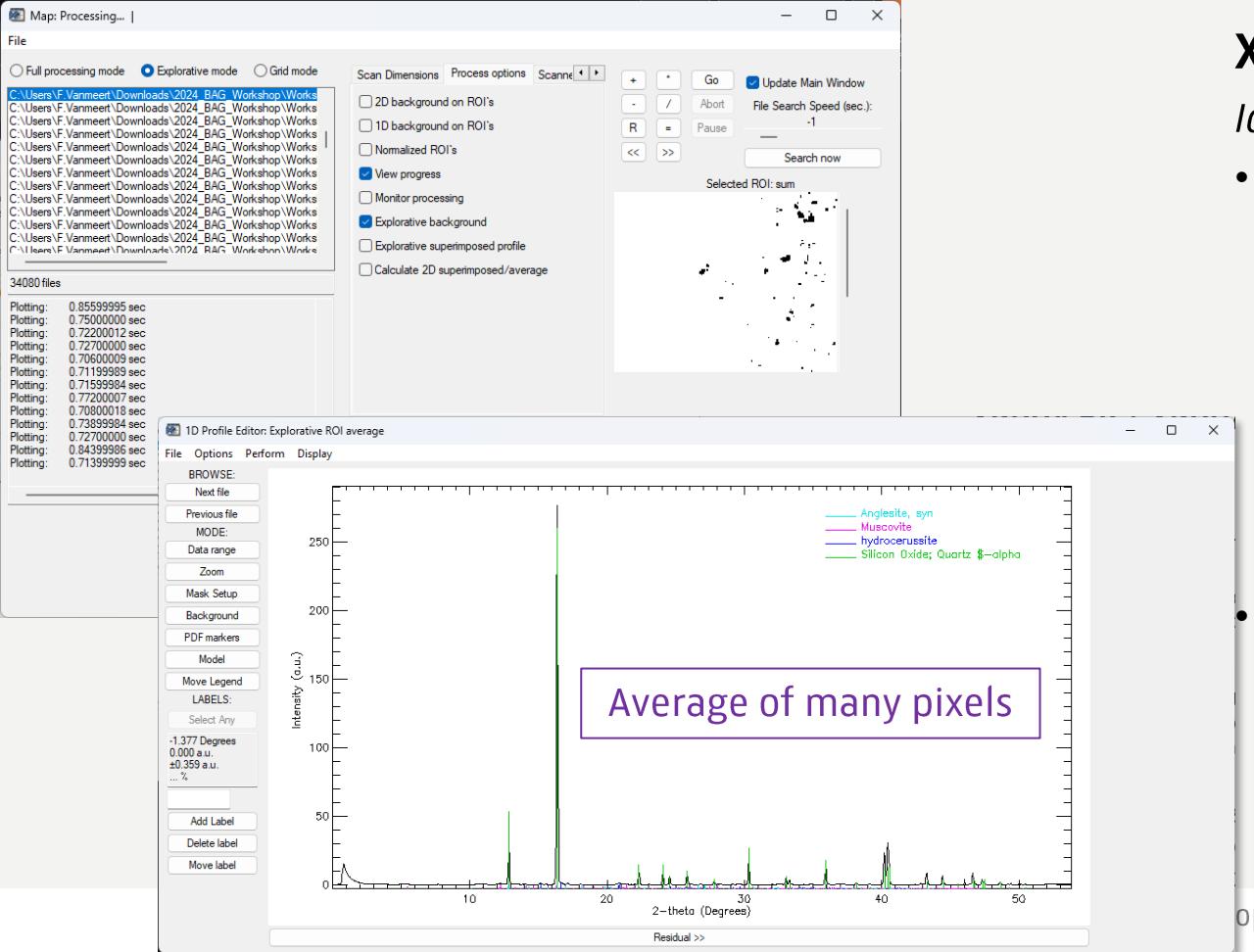
XRDUA BP + XRDUA 1D

Identifying compounds

- Several artefacts can make identification difficult and/or impossible
 - Preferred orientation: this causes a (strong) difference in relative intensity
 - “Large” crystals: this results in very strong intensities for one or a limited number of diffraction peaks for the given crystal
 - No physical sample preprocessing is possible to reduce these artefacts, so be aware of the limitations of your data!

op

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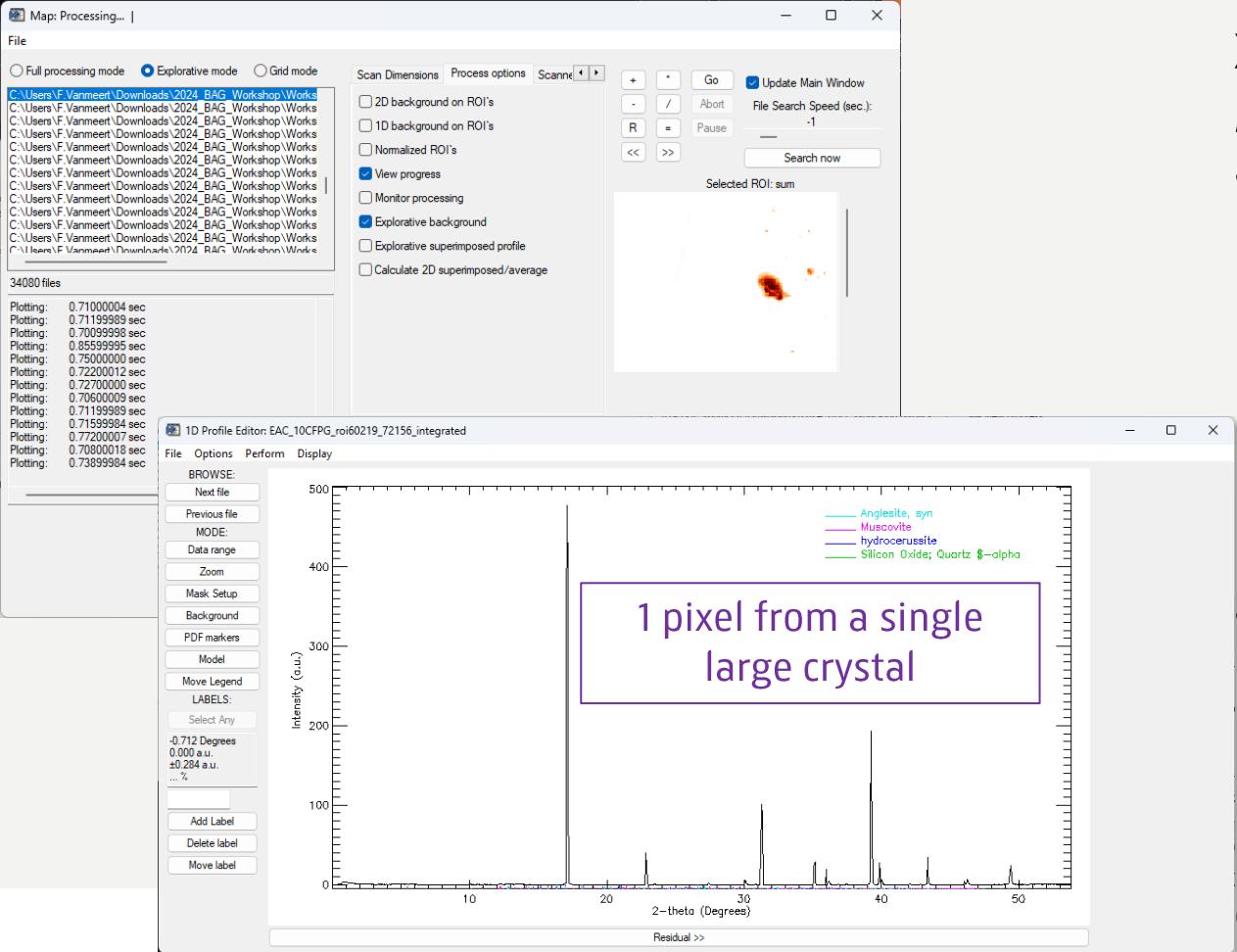


3. Identifying compounds

XRDUA BP + XRDUA 1D

Identifying compounds

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3. Identifying compounds

XRDUA BP + XRDUA 1D

Identifying compounds

- Several artefacts can make identification difficult and/or impossible
 - Preferred orientation: this causes a (strong) difference in relative intensity
 - “Large” crystals: this results in very strong intensities for one or a limited number of diffraction peaks for the given crystal
- No physical sample preprocessing is possible to reduce these artefacts, so be aware of the limitations of your data!

My strategy (depends on the goal of the analysis):

- Identify all main phases of the average profile, using as much prior information as you have.
- Use ROIs on peaks of an unknown phase to obtain a good 1D profile for that phase using **XRDUA BP** (single pixel or average). Identify it with available PDFs or with dedicated software (Match!, QualX2, ...).
- Repeat this for all/most signals.
- Create a small ROI window in **XRDUA BP** and ‘scan’ this over the entire angular range and/or place ROI selectively on angles for which you expect a diffraction peak of a specific phase to check for meaningful 2D intensity distributions.
- Be aware of the limits of your data (preferred orientation, “large” crystals, ...).
- Create your fitting model gradually.

XRDUA BP + XRDUA 1D

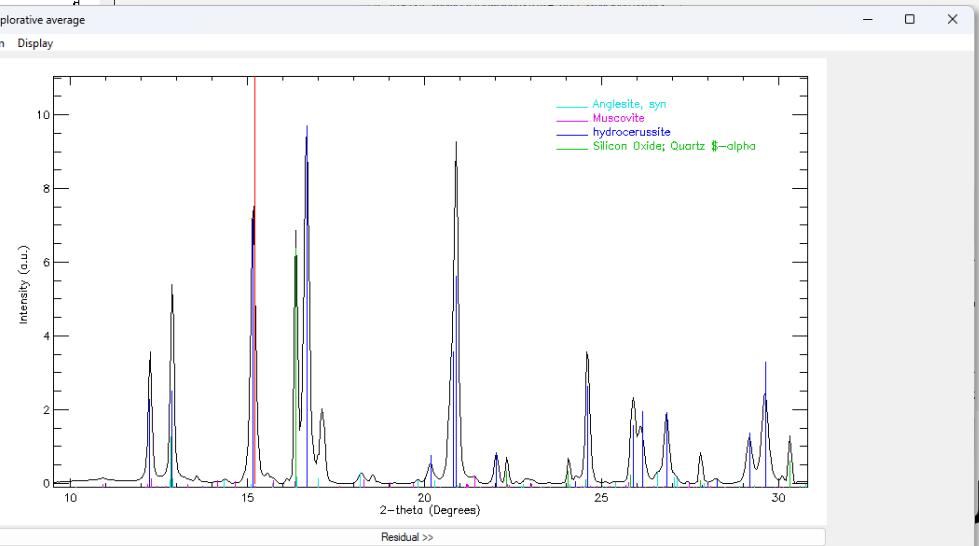
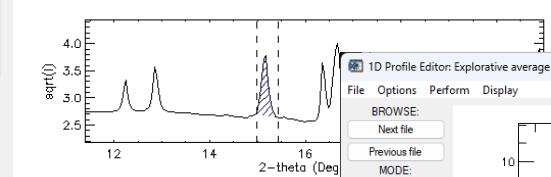
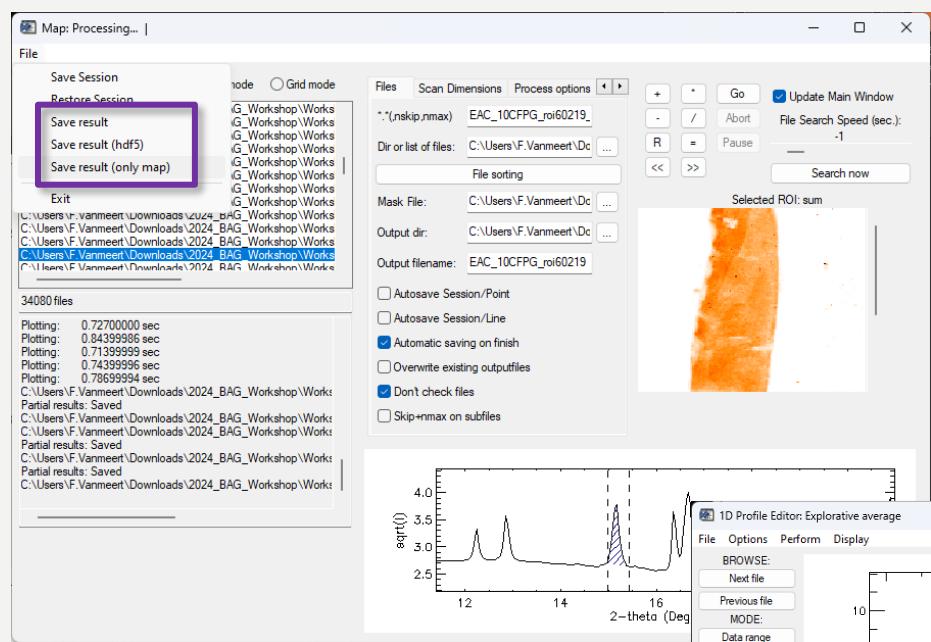
Identifying compounds

- This is the process that (usually) **requires the most time from the user**.
- A priori knowledge and complementary information are very helpful
- Sometimes it’s good to be stubborn and keep trying ;-)

XRDUA BP + XRDUA 1D

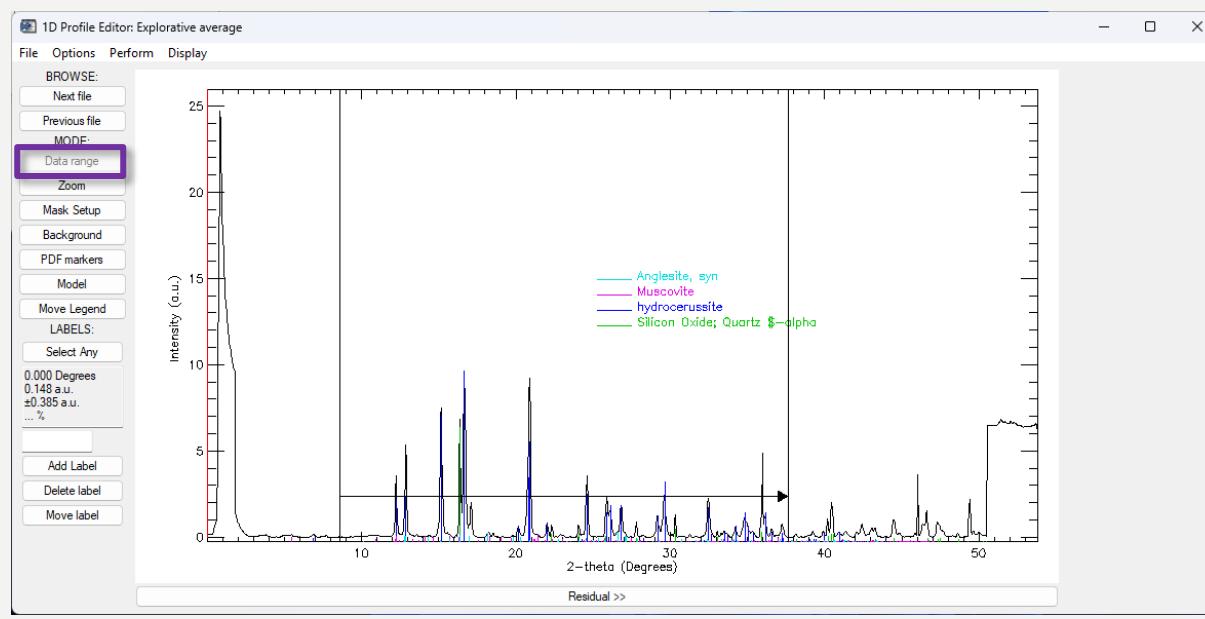
Saving ROI images

- Select ROI around peak of interest
- Check correct selection of peak in XRDUA 1D (when “Update Main Window” is checked)
- Save result (only map)



4. Saving ROI images

JM



XRDUA 1D

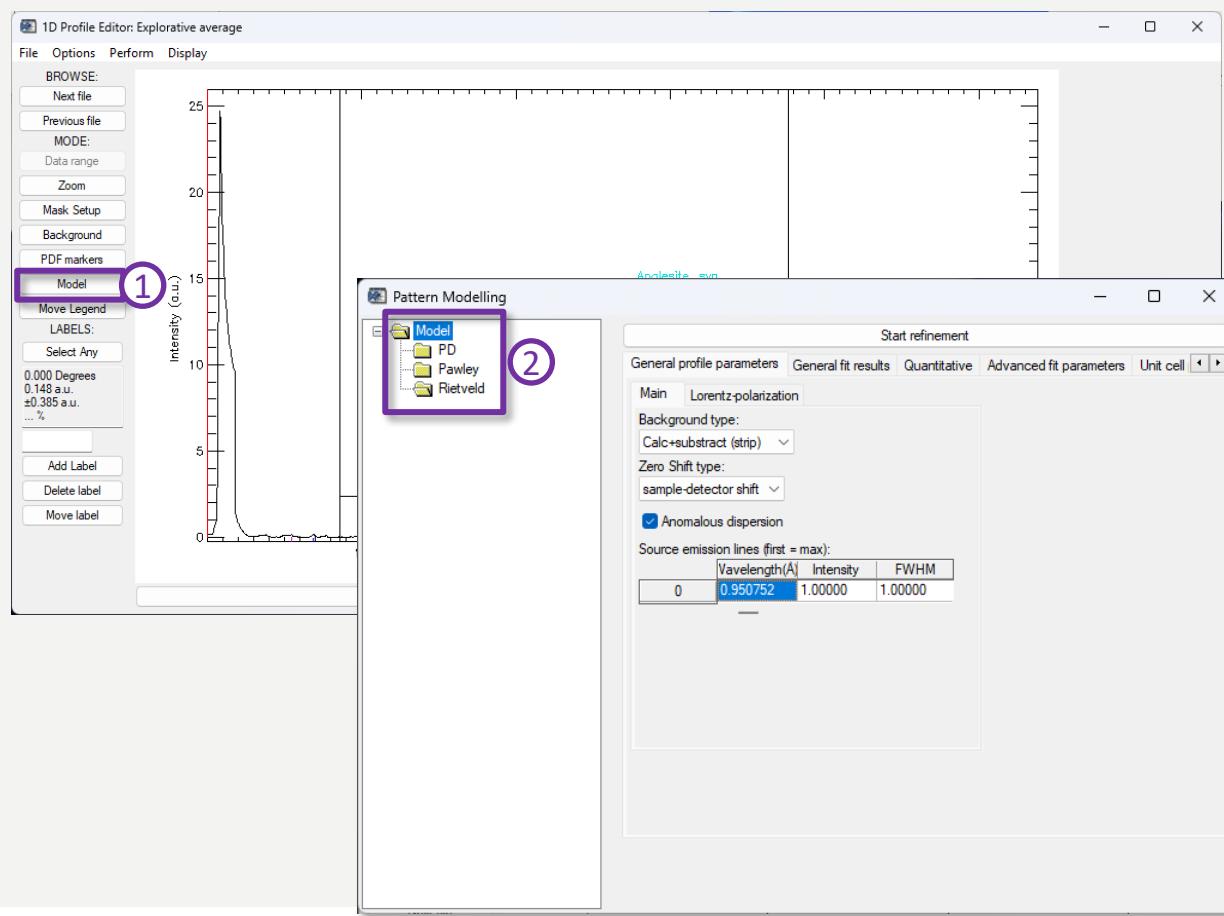
Select Data Range

- Select the data range that you want to include in your fit model
- Typically:
 - Large scattering angles produce signals of low intensity or there is a lot of overlap with other phases
 - Low scattering angles show the drop in intensity of the beam stop and the decrease in intensity of the primary beam and beam scatter
 - If your phases of interest are not in those regions, avoid putting them in your model.

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5. Creating a Fit Model

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XRDUA 1D + Model

Main Model window

1. Model

- General fit parameters
- Default settings should be fine for most cases
- Change Background type if you didn't use 'strip' background

2. Different 'structural' and 'structureless' groups to use in the fitting model

- convert
- **Rietveld**: uses complete crystal structure (unit cell parameters, atomic coordinates, SOF, ...)
 - **Pawley**: uses crystal structure information without atomic information
 - **PD**: contains no structural information (list of peak positions, intensities and widths)

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5. Creating a Fit Model

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Full processing mode Explorative mode Grid mode

```
C:\Users\F.Vanmeert\Downloads\2024_BAG_Workshop\Works
```

34080 files (progress: 34080/34080)

Make Plotting window: 2.7539999 sec

Plotting: 0.83799982 sec

Image scaling 116.640%

Make Plotting window: 3.0060000 sec

Plotting: 0.88700008 sec

Intensity scaling at 100.000%

Make Plotting window: 3.9419999 sec

Plotting: 1.0590000 sec

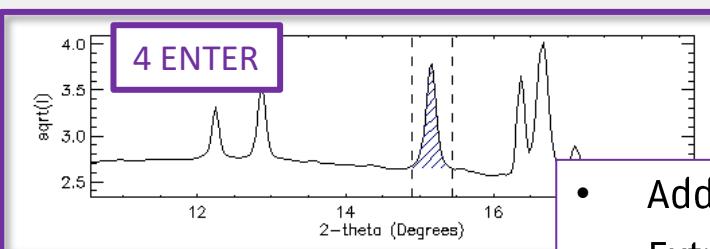
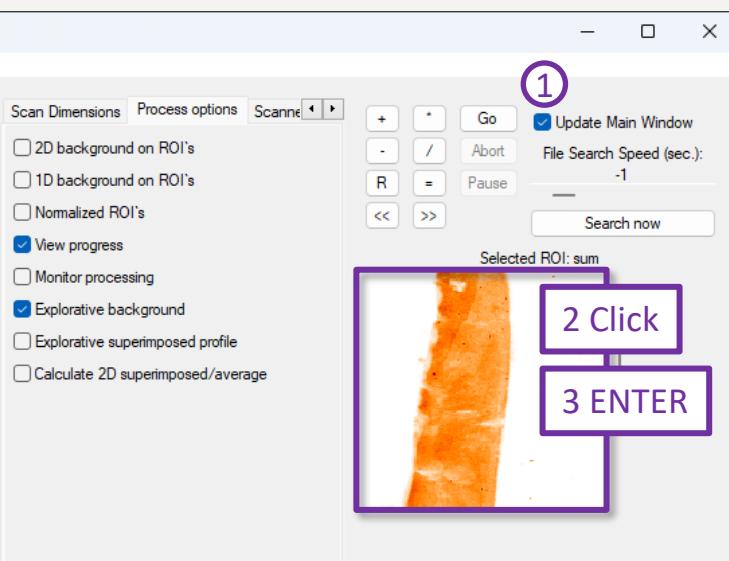
Plotting: 0.91100001 sec

Plotting: 0.85399985 sec

Plotting: 0.84999990 sec

Plotting: 0.82099986 sec

Plotting: 0.89499998 sec

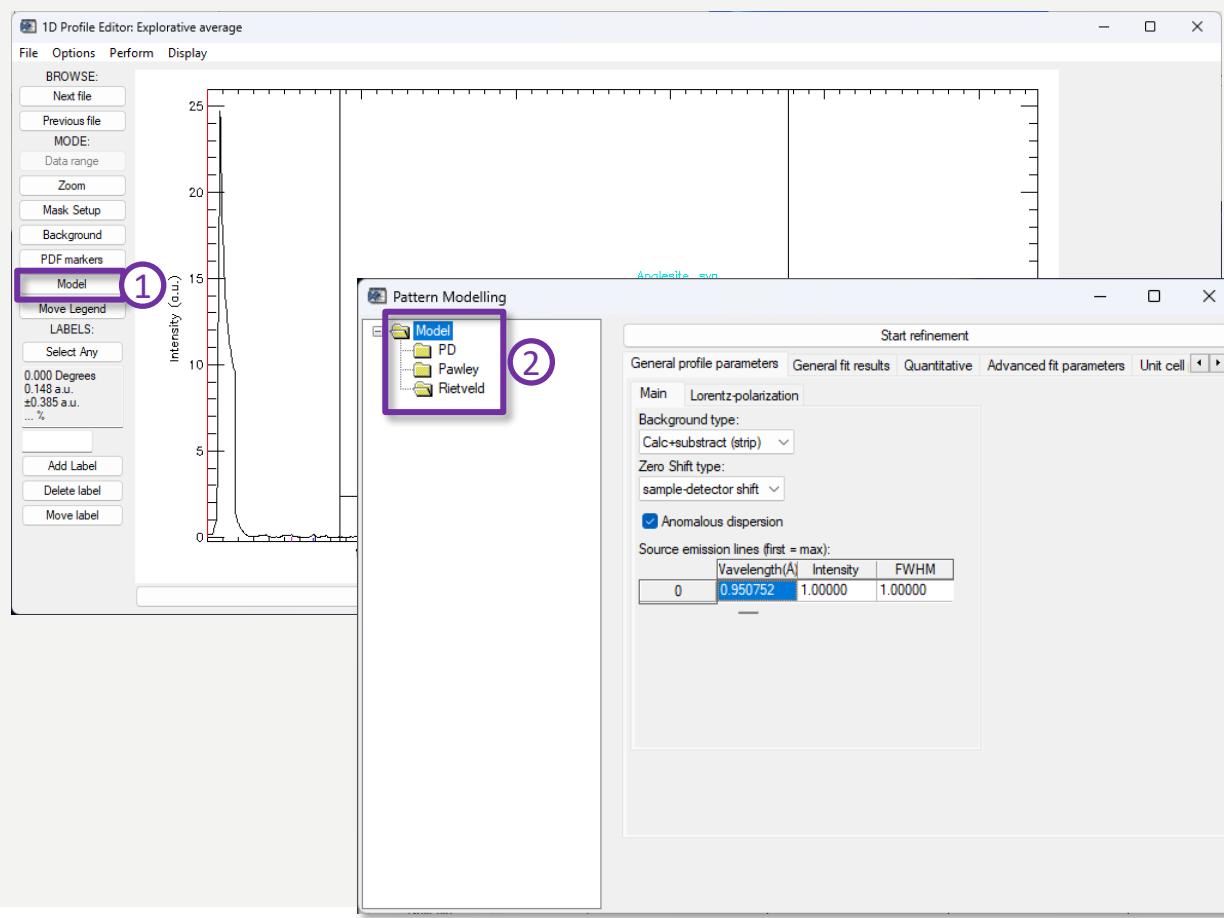


XRDUA BP

Link to XRDUA 1D

1. Update Main Window
2. Click pixel in ROI image
 - Loads 1D profile of that pixel to XRDUA 1D
3. Press ENTER when cursor is in ROI image
 - Loads averaged (or superimposed) 1D profile based on current ROI intensity in XRDUA 1D
4. Press ENTER when cursor is in 1D profile
 - Loads averaged (or superimposed) 1D profile in XRDUA 1D

- Add groups to the model step by step
- Extract a suitable 1D profile in which the phase(s) of interest is/are clearly present.
- Use contrast/intensity scaling when needed to visualize the distribution.



XRDUA 1D + Model

Main Model window

1. Model

- General fit parameters
- Default settings should be fine for most cases
- Change Background type if you didn't use 'strip' background

2. Different 'structural' and 'structureless' groups to use in the fitting model



Rietveld: uses complete crystal structure (unit cell parameters, atomic coordinates, SOF, ...)

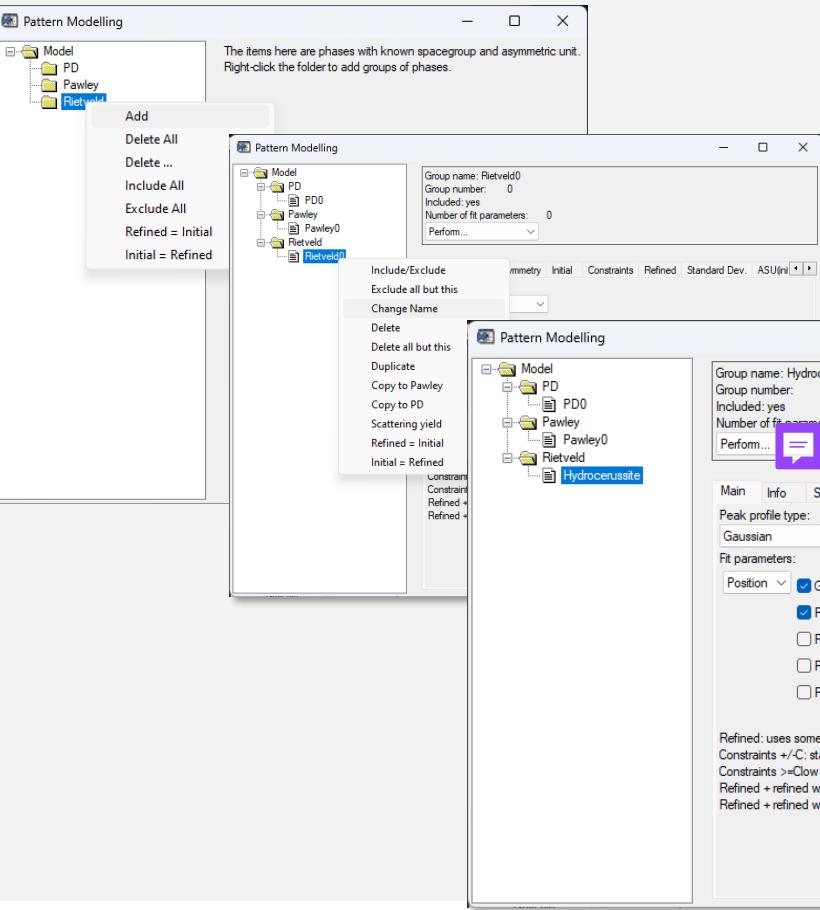
Pawley: uses crystal structure information without atomic information

PD: contains no structural information (list of peak positions, intensities and widths)

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5. Creating a Fit Model

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Model

Working with fitting groups

- Right-click on the group for options
- Add ‘peak group’ to different structural groups
- Change name of ‘peak group’



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5. Creating a Fit Model

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Pattern Modelling

- Model
 - PD
 - PD0
 - Pawley
 - Pawley0
 - Rietveld
 - Hydrocerussite

Group name: Hydrocerussite
Group number: 0
Included: yes
Number of fit parameters: 3

Perform...
Perform...
Load Structure File
Save Structure File
Add ASU position
Delete Peaks With...
Delete Small Peaks...
Reset Unit Cell
Recalculate HKL
Save Peak param...
Save FWHM...
Save SNR...
Save Peaks as PDF...
5 1.00000 0.00000 7.00000 6.00000 0.100000

Initial Constraints Refined Standard Dev. ASU(init) ASU(constr) ASU(ref) ASU(SD)
Ref = fixed

k	l	m	FWHM_L
0.00000	1.00000	6.00000	0.100000
0.00000	-2.00000	6.00000	0.100000
0.00000	6.00000	2.00000	0.100000
0.00000	4.00000	6.00000	0.100000
0.00000	-5.00000	6.00000	0.100000

Global position parameters:
d_{dist}(mm) a b c alpha beta gamma
0 0.00000 5.24650 5.24650 23.7020 90.0000 90.0000 120.000

Global intensity parameters:
scaling
0 0.00000

Global FWHM parameters:
U V W IG
0 0.00000 0.00000 0.0100000 0.00000

0.00000 This value will be refined by the model

5.24650 These values will NOT be refined by the model

0.10000

Model

Rietveld Group

- Load Structure from structure file 
- E.g., cif files from COD or AMCSD
- .cel from XRDUA
- Initial
 - Shows miller indices, multiplicity of the different diffraction peaks within the selected data range
 - Unit cell parameters
- Constraints
 - Set constraints on the parameters that are refined
- Refined
 - Refined values obtained by the model

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5. Creating a Fit Model

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This site is an interface to a crystal structure database that includes every structure published in the American Mineralogist, The Canadian Mineralogist, European Journal of Mineralogy and Physics and Chemistry of Minerals, as well as selected datasets from other journals. The database is maintained under the care of the Mineralogical Society of America and the Mineralogical Association of Canada and financed by the National Science Foundation.

<input type="text" value="hydrocerussite"/>	Mineral
	Author
	Chemistry Search
	Cell Parameters and Symmetry
	Diffraction Search
	General Search
	Search Tips
<input type="button" value="Search"/>	<input type="button" value="Reset"/>
Logic interface	
<input checked="" type="radio"/> AND <input type="radio"/> OR	
Viewing (About File Formats) <input type="radio"/> amc long form <input type="radio"/> amc short form <input checked="" type="radio"/> cif	
Download <input type="radio"/> amc <input checked="" type="radio"/> cif <input type="radio"/> diffraction data	



Number of Files downloaded since Apr 1, 2003: 1180206959

Data Last Updated: January 08, 2024

Web Page Last Updated: July 31, 2018

This page has been accessed 4640655 times.

Also see our [complete list of minerals](#) and [complete list of authors](#).

This material is based upon work supported by the National Science Foundation under Grant Nos. EAR-0112782, and EAR-062 conclusions or recommendations expressed in this material are those of the authors and do not necessarily reflect the views of

Should the use of the database require a citation, then please use: Downs, R.T. and Hall-Wallace, M. (2003) The American Mineralogist Database. American Mineralogist 88, 247-250. ([pdf file](#))

Contact [Robert T. Downs](#) for suggestions and corrections.

Hydrocerussite

Siidra O, Nekrasova D, Depmeier W, Chukanov N, Zaitsev A, Turner R
 Acta Crystallographica B74 (2018) 182-195
 Hydrocerussite-related minerals and materials: structural principles, chemical variations and infrared spectroscopy
 Locality: synthetic
 $_database_code_amcsd\ 0020727$
 5.257 5.257 23.636 90 90 120 R-3m
 atom x y z occ Uiso U(1,1) U(2,2) U(3,3) U(1,2) U(1,3) U(2,3)
 Pb1 0 0 .21570 .0271 .0249 .0249 .0314 .0125 0 0
 Pb2 .9153 -.9153 .00191 1/6 .0286 .0337 .0337 .0279 .0238 -.0015 .0015
 C 1/3 2/3 .2337 .031 .012 .012 .068 .006 0 0
 O .8083 -.8083 -.0979 .038 .032 .032 .063 .026 -.001 .001
 OH 0 0 .3124 .070 .090 .090 .030 .045 0 0

[Download AMC data \(View Text File\)](#)

[Download CIF data \(View Text File\)](#)

[Download diffraction data \(View Text File\)](#)

[View Jmol 3-D Structure \(permalink\)](#)

Hydrocerussite

Martinetto P, Anne M, Dooryhee E, Walter P, Tsoucaris G
 Acta Crystallographica C58 (2002) i82-i84
 Synthetic hydrocerussite, $2PbCO_3 \cdot Pb(OH)_2$ by X-ray powder diffraction
 Locality: synthetic
 $_database_code_amcsd\ 0010324$

5.2465 5.2465 23.702 90 90 120 R-3m

atom x y z occ Uiso
 Pb1 0 0 .21510 .0172
 Pb2 .9158 -.9158 .0016 1/6 .0215
 C 0 0 .4304 .028
 O1 .8568 -.8568 .4318 .028
 OH2 -.293 .293 .0200 1/3 .010

[Download AMC data \(View Text File\)](#)

[Download CIF data \(View Text File\)](#)

[Download diffraction data \(View Text File\)](#)

[View Jmol 3-D Structure \(permalink\)](#)

Download in:

Multiple datasets can be concatenated into a single downloadable file by selecting the datasets and then clicking [Download as Text File](#)

Multiple datasets can be downloaded as individual files inside a ZIP archive by selecting the datasets and then clicking [Download as Zip Archive](#)

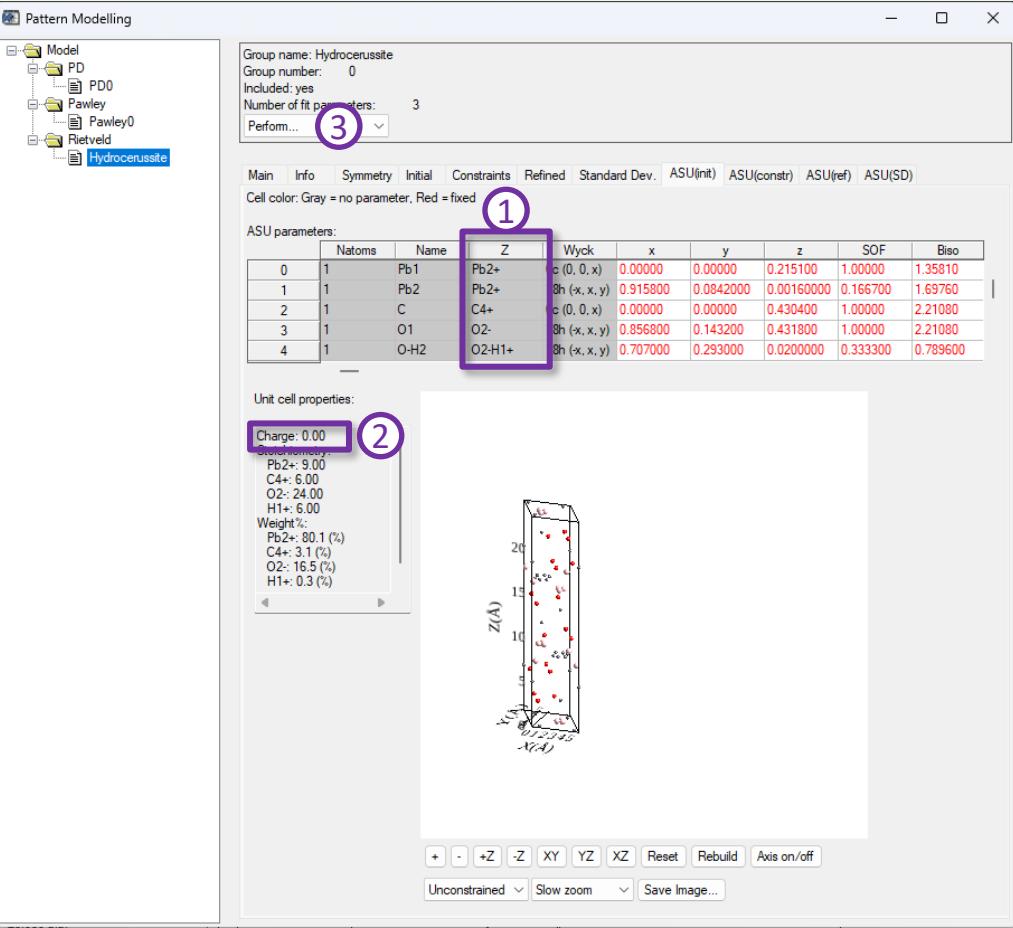
Total number of retrieved datasets: 4

[View in amclongform](#), download in amc

[Return to AMCSD Home Page](#)

5. Creating a Fit Model

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5. Creating a Fit Model

Model

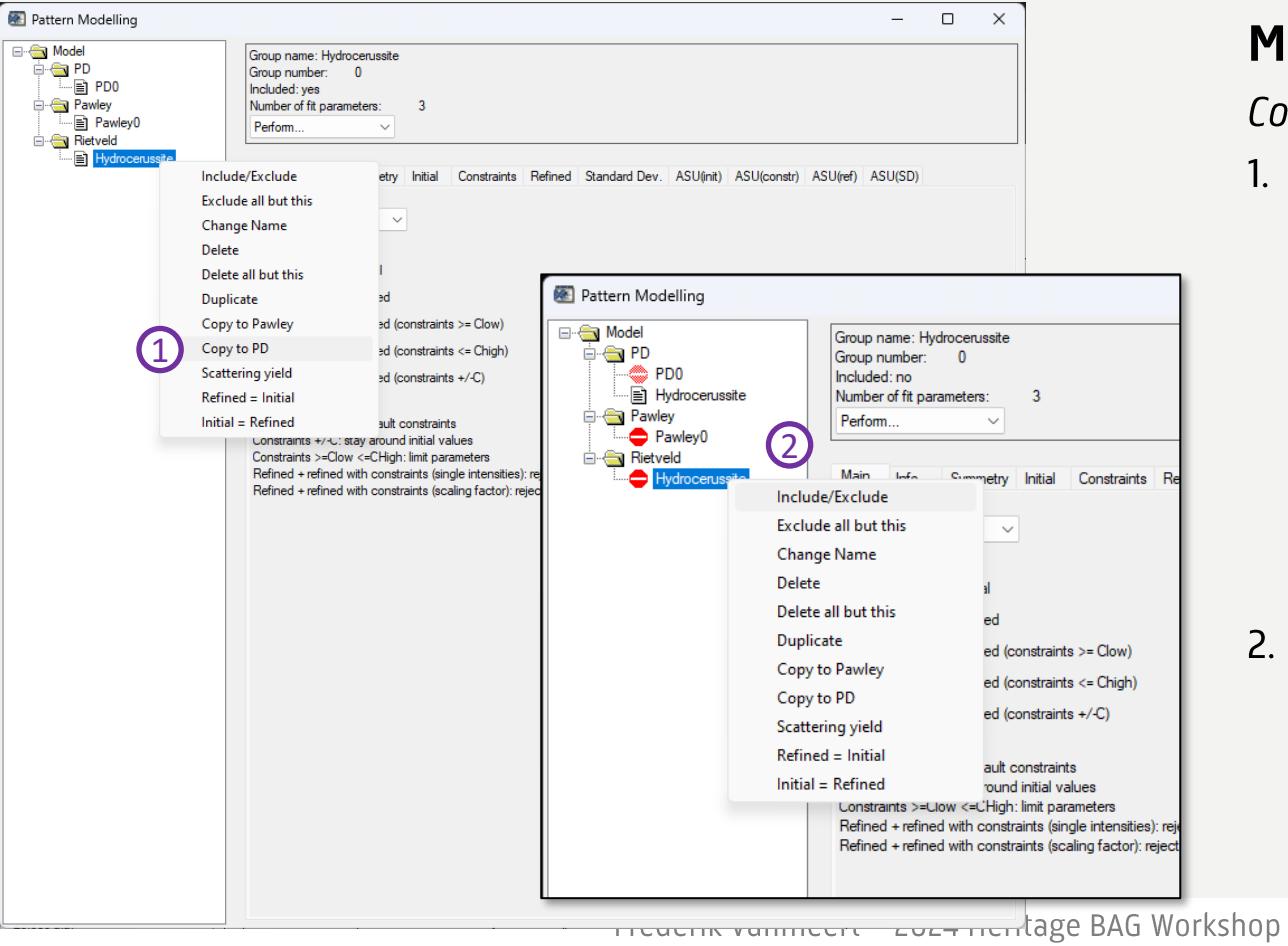
Rietveld Group

- ASU(init)

- Atomic structure information
- Charges are default, unless the structure is loaded from a XRDUA .cel file

- Set proper charges

1. Z, e.g.,
 - Pb: Pb2+
 - OH-: O2-H1+
 - H2O: O2-H1+2
2. Charge: 0.00
3. You can modify and save the structure as a .cel file (Perform ...)



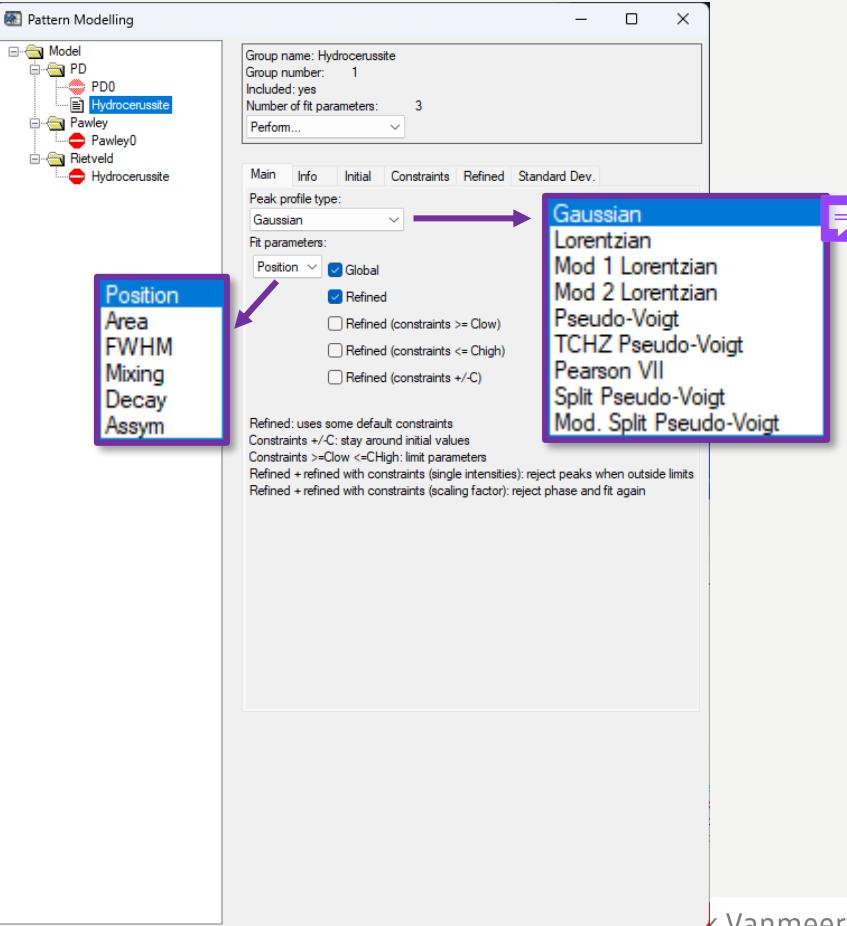
Model

Convert Rietveld to PD

1. Peak positions and relative intensities are calculated based on the structural information in the Rietveld model. To speed up the fit, convert the Rietveld group to a PD group (i.e., a list of positions, relative intensities and widths).
2. Exclude irrelevant groups and the Rietveld group from the fit

5. Creating a Fit Model

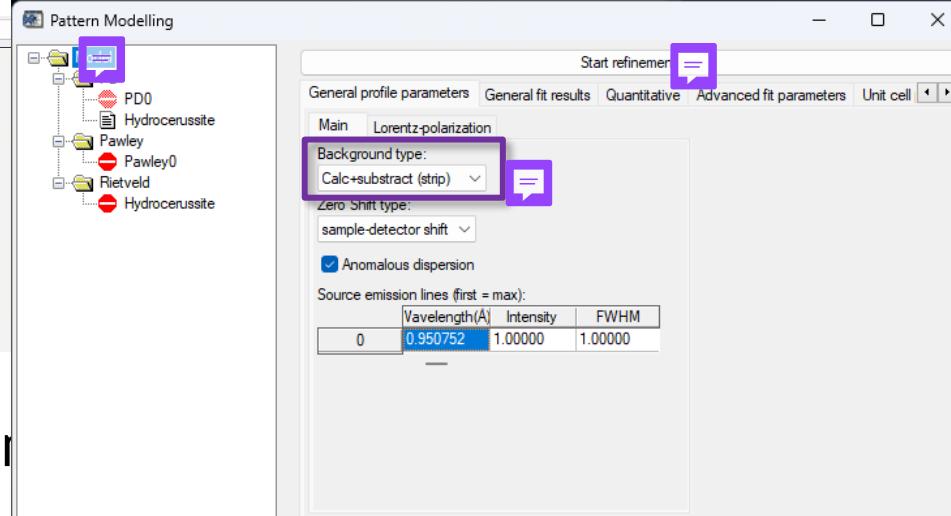
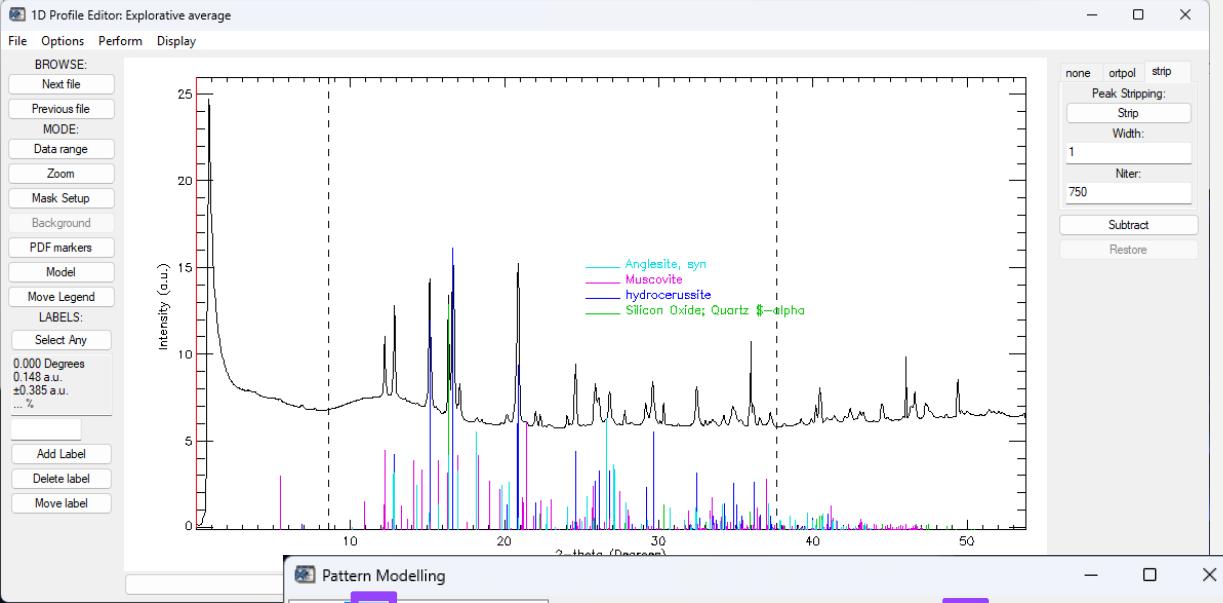
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Model

Main group window

- Chose Peak profile type
- Select which parameters to refine
- ‘Global’ to link various parameters during refinement
 - **Position:** are refined by a single parameter ‘sample-detector distance’)
 - **Area:** intensity is scaled using a single scaling factor
 - **FWHM:** widths are refined using the Cagliotti peak width function



XRDUA 1D + Model

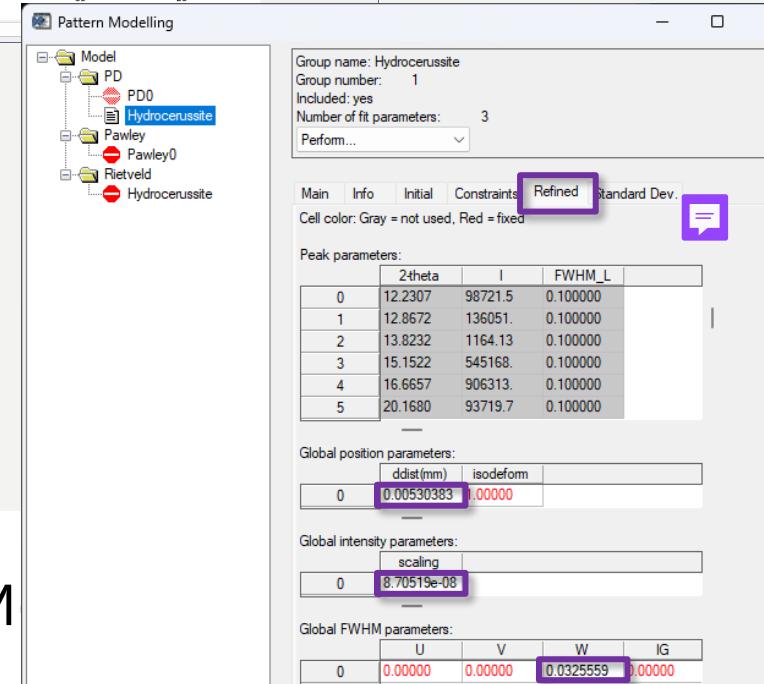
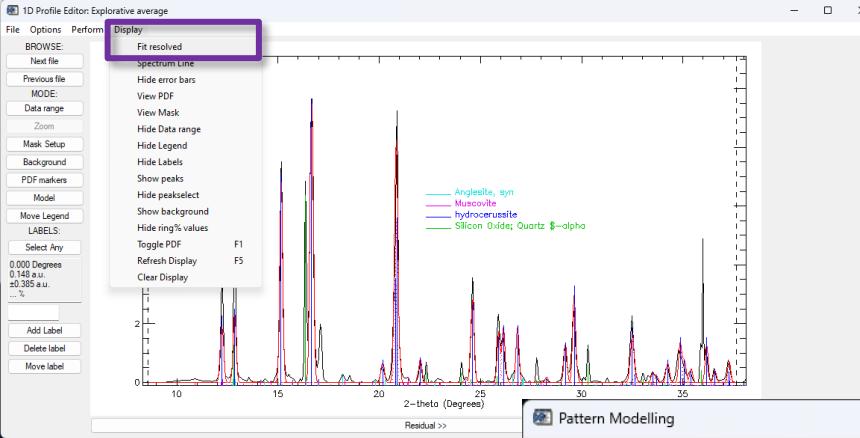
First Fitting

- Make sure to restore the background in XRDUA 1D, since the main model window has 'Background type: 'Calc+subtract (strip)'
- Start refinement

5. Creating

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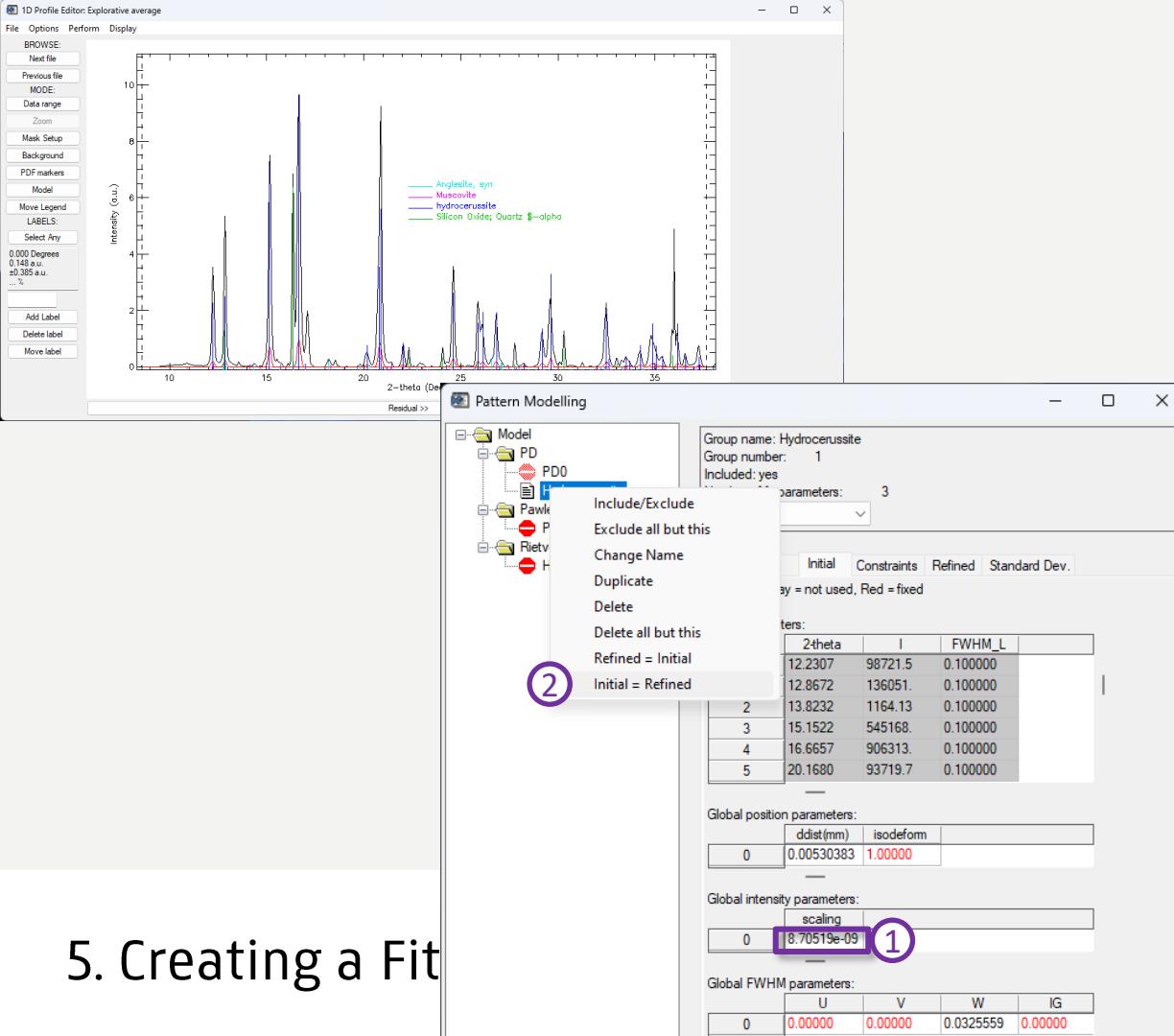
5. Creating a Fit M

XRDUA 1D + Model

Find good starting values

1. Subtract background again
2. Click ‘Fit Total’ (changes to ‘Fit resolved’)
3. The refined tab shows the refined values for the different parameters

- ddist: offset to sample-detector distance
- scaling
- W: Cagliotti theta independent peak width parameter



5. Creating a Fit

XRDUA 1D + Model

Find good starting values

- Check the refined values (**Model**) and the fit (**XRDUA 1D**)
1. Decrease the value for scaling. This value is too high as a starting value for pixels that do not contain this phase
 2. Copy the refined values to the initial values for the model

hop

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XRDUA 1D + Model

Set constraints

- It's best to constrain the position and width to avoid unrealistic values

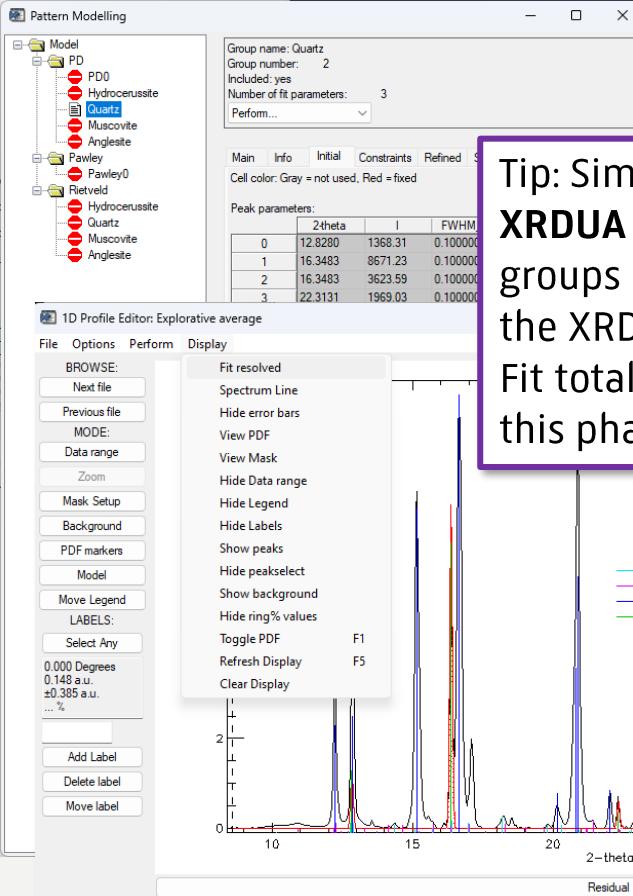
- Refined (constraints +/-C)
 - This constraints the value based on the initial value and a constant
- Set the constants to be used as constraints
 - This depends on your sample, but a good start is e.g.,
 - ddist: 1 mm
 - W: ca. 1/3 of initial value

Tip: Rerun the fit to check that no mistake was made (do not forget to restore the background)

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5. Creating a Fit Model

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Tip: Simplify the fit visualization in the XRDUA 1D window by excluding all groups except the phase of interest. In the XRDUA 1D window go to Display -> Fit total. Now only the contribution of this phase to the fit is shown.

XRDUA 1D + Model

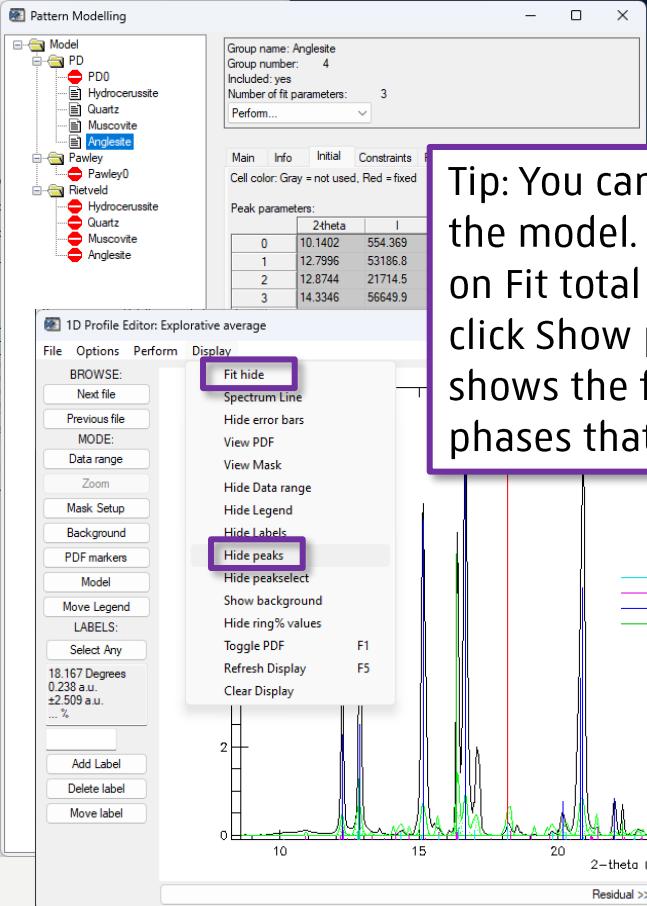
Add a new group for the next phase and repeat the procedure

- Find a suitable 1D profile
- Create Rietveld group
- Load structure file
- Check charges
- Copy to PD
- Start refinement
- Check fit and refined values and lower the intensity value
- Set Initial = Refined
- Set constraints
- Rerun fit

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5. Creating a Fit Model

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Tip: You can show your initial estimate for the model. For this, remove the fit (click on Fit total until the fit disappears) and click Show peaks. The profile in green shows the fit with the initial values for the phases that are included in the model

XRDUA 1D + Model

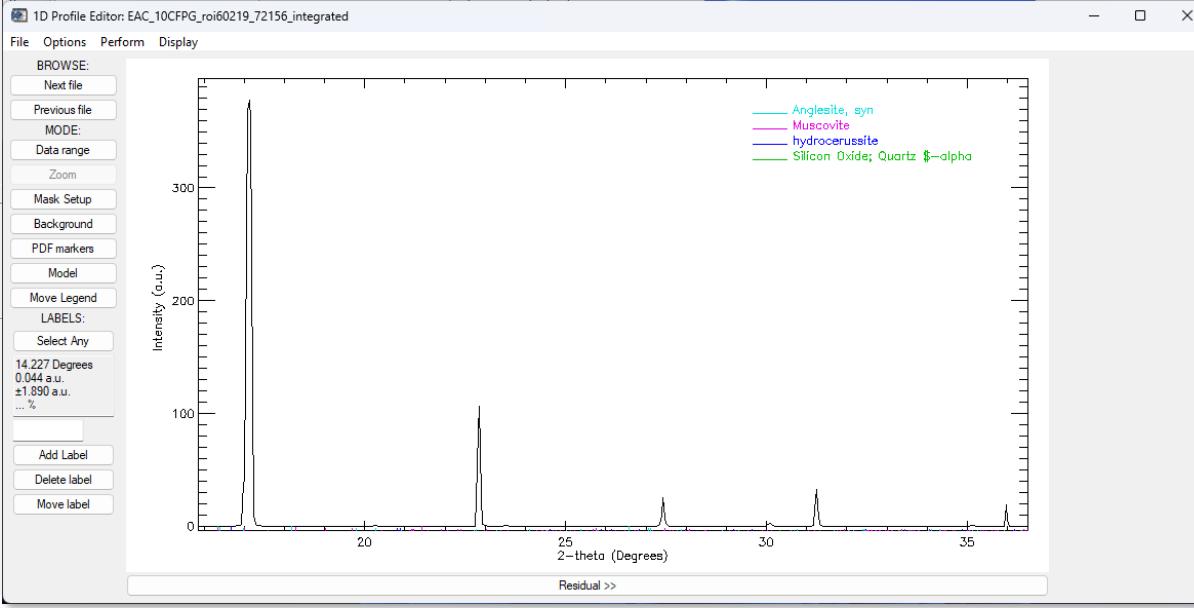
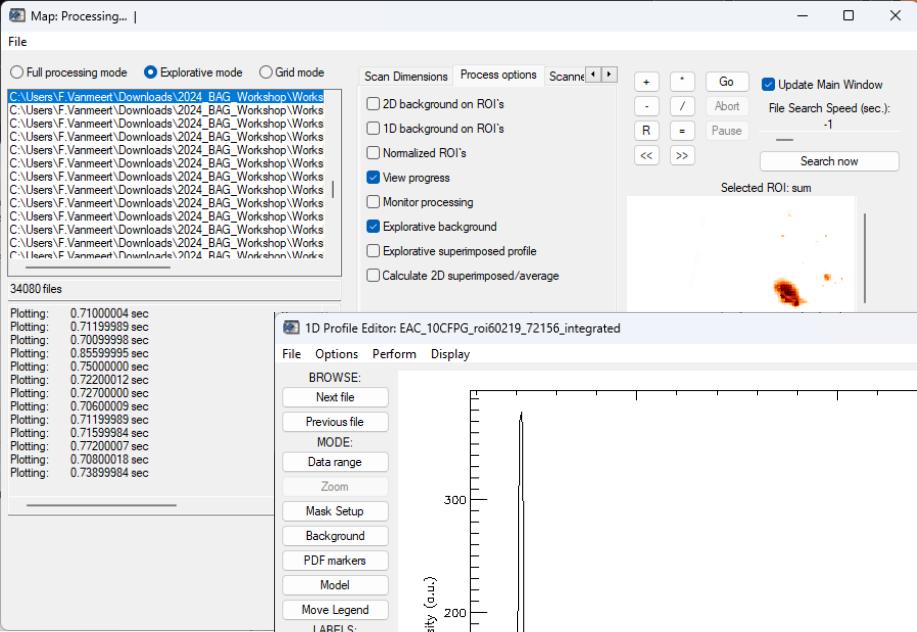
Add a new group for the next phase and repeat the procedure

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- Check charges
- Copy to PD
- Start refinement
- Check fit and refined values and lower the intensity value
- Set Initial = Refined
- Set constraints
- Rerun fit

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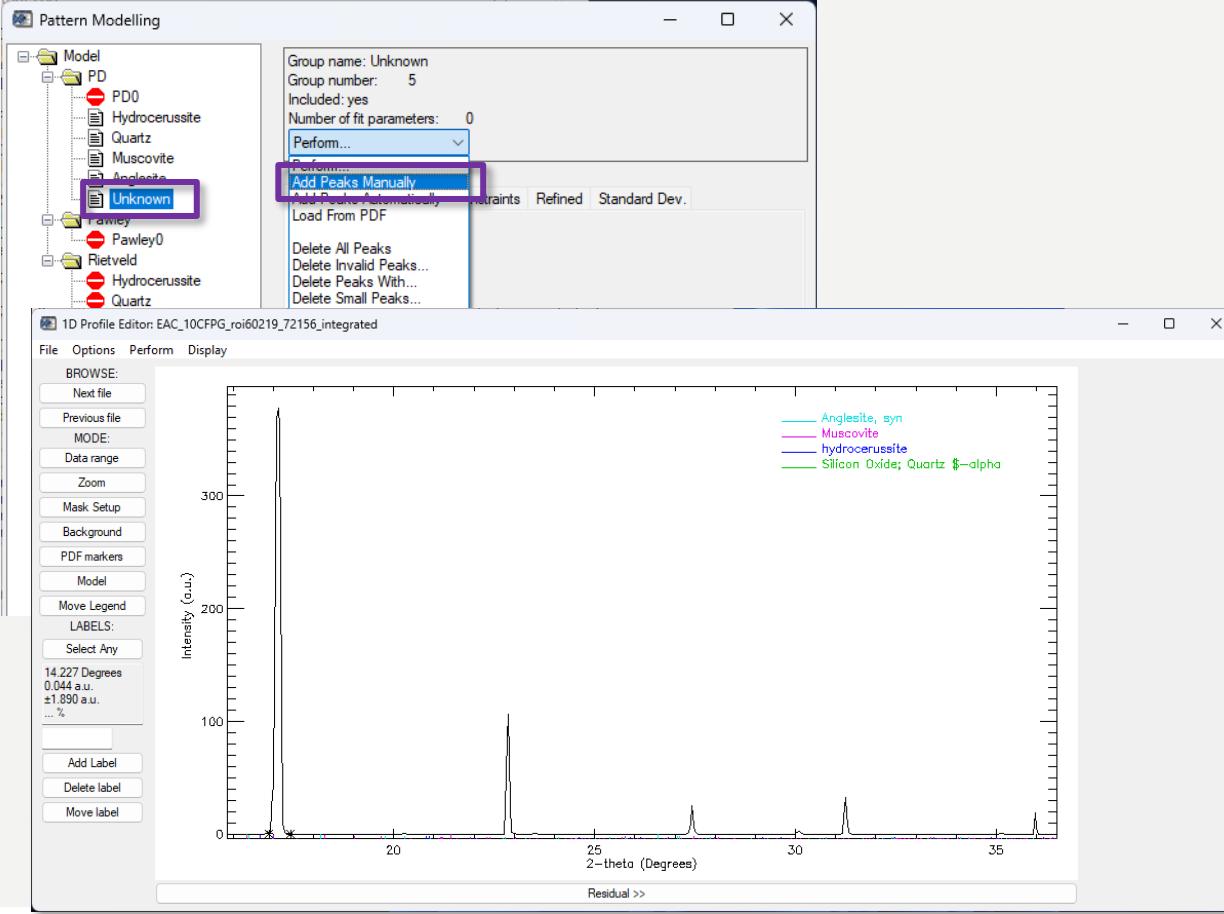
XRDUA 1D + Model

Unknown phase

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XRDUA 1D + Model

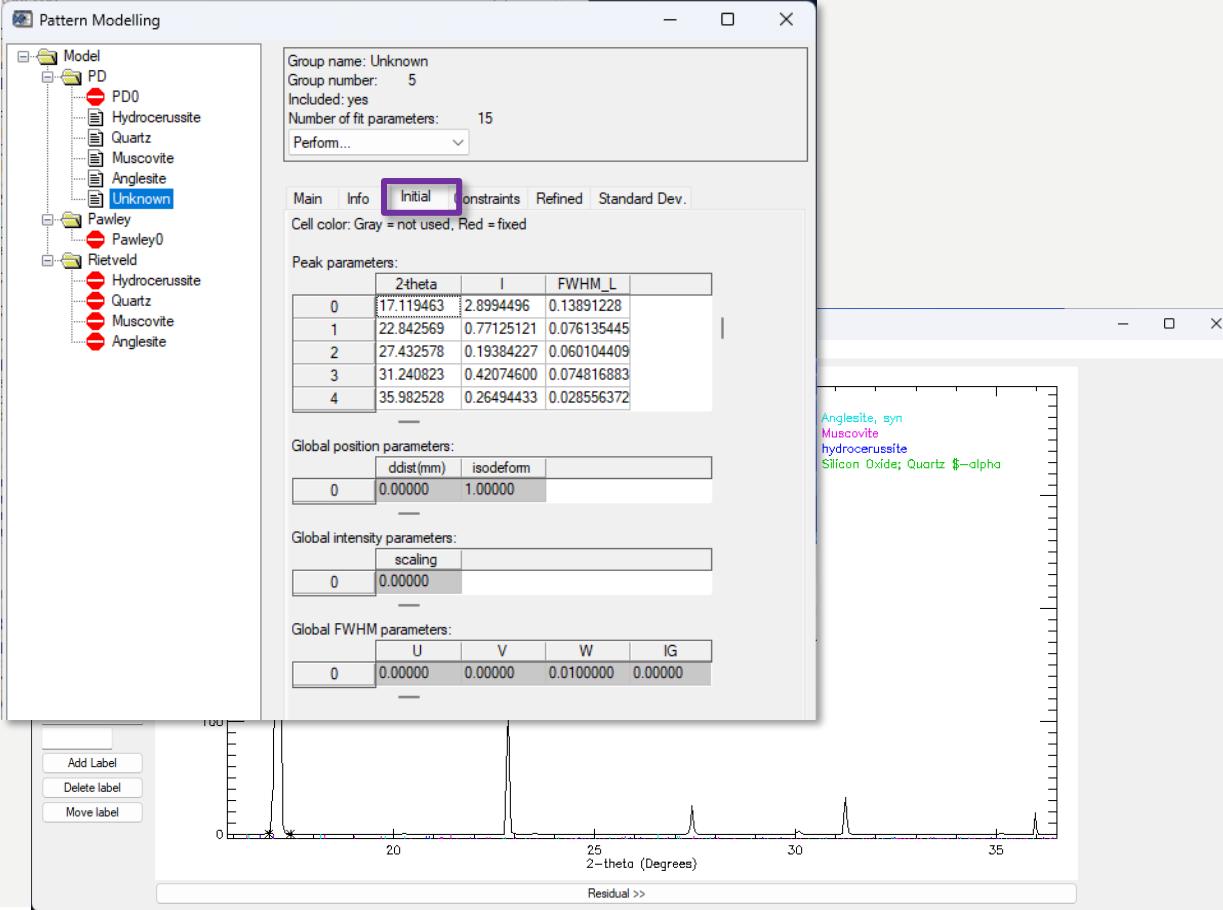
Unknown phase

- Create a PD group (since no structural information is known)
- Add Peaks Manually and click and drag from left to right over the peak to add

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XRDUA 1D + Model

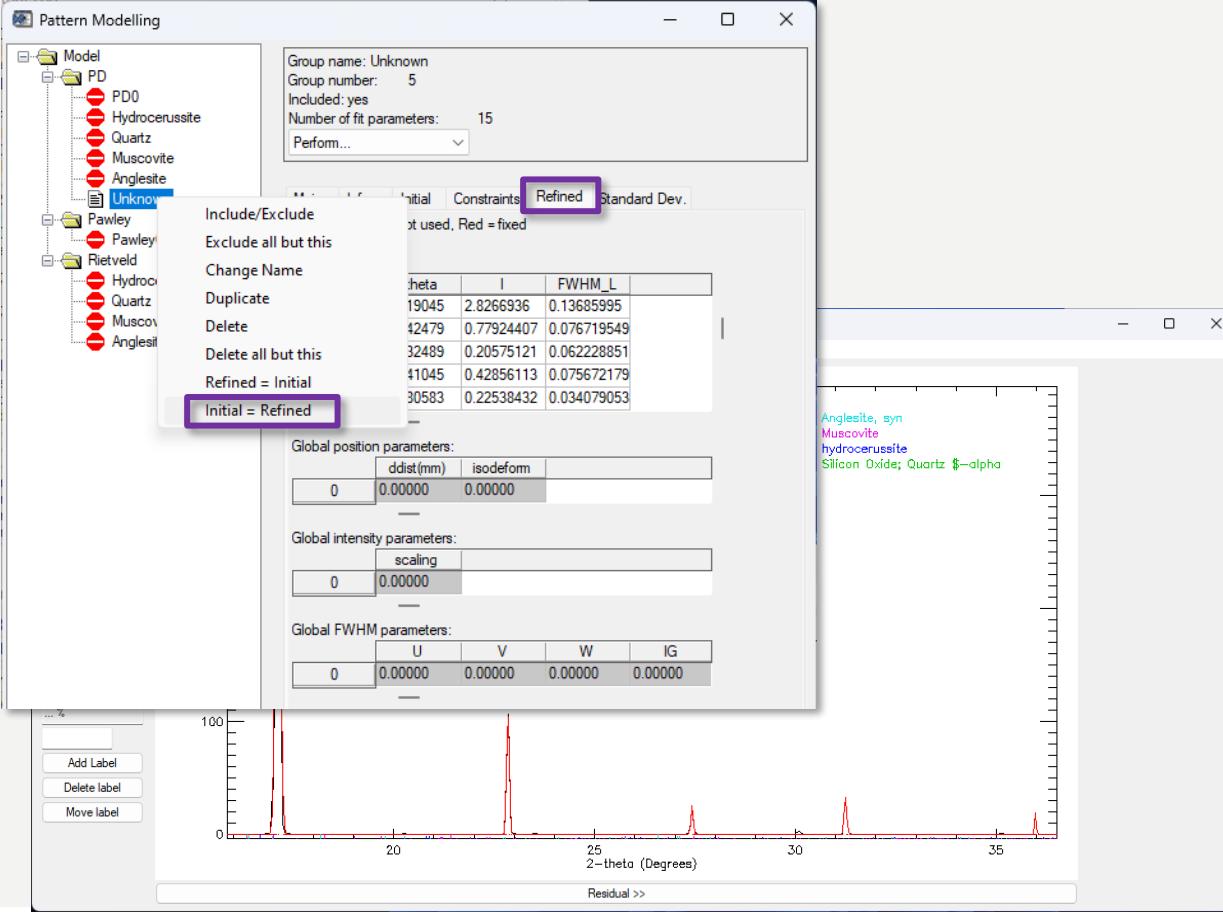
Unknown phase

- Create a PD group (since no structural information is known)
- Add Peaks Manually and click and drag from left to right over the peak to add
- Under the initials tab, you will see the peaks being added with a position, intensity and width

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XRDUA 1D + Model

Unknown phase

- Create a PD group (since no structural information is known)
- Add Peaks Manually and click and drag from left to right over the peak to add
- Under the initials tab, you will see the peaks being added with a position, intensity and width
- To get better starting values for the fit, start the refinement and check if the fit looks good.
- Perform Initial = Refined

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5. Creating a Fit Model

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Pattern Modelling

Group name: Unknown
Group number: 5
Included: yes
Number of fit parameters: 3

① Main Info Initial Constr

Peak profile type: Gaussian

Fit parameters:

- Position Global Refined Refined (const)
- Refined (const)
- Refined (const)
- Refined (const)

Refined: uses some default const
Constraints +/-C: stay around init
Constraints >=Clow <=Chigh: limit
Refined + refined with constraints
Refined + refined with constraints

Group name: Unknown
Group number: 4
Included: yes
Number of fit parameters: 6

② Main Info Initial Constraints Refined Standard Dev.

Cell color: Gray = not used, Red = fixed

Peak parameters:

	2-theta	I	FWHM_L
0	17.1190	2.82669	0.136860
1	22.8425	0.779244	0.0767196
2	27.4325	0.205751	0.0622289
3	31.2410	0.428561	0.0756722
4	35.9806	0.225384	0.0340791

Global position parameters:

ddist(mm)	isodeform	
0	0.00000	1.00000

Global intensity parameters:

scaling	
0	0.00000

Global FWHM parameters:

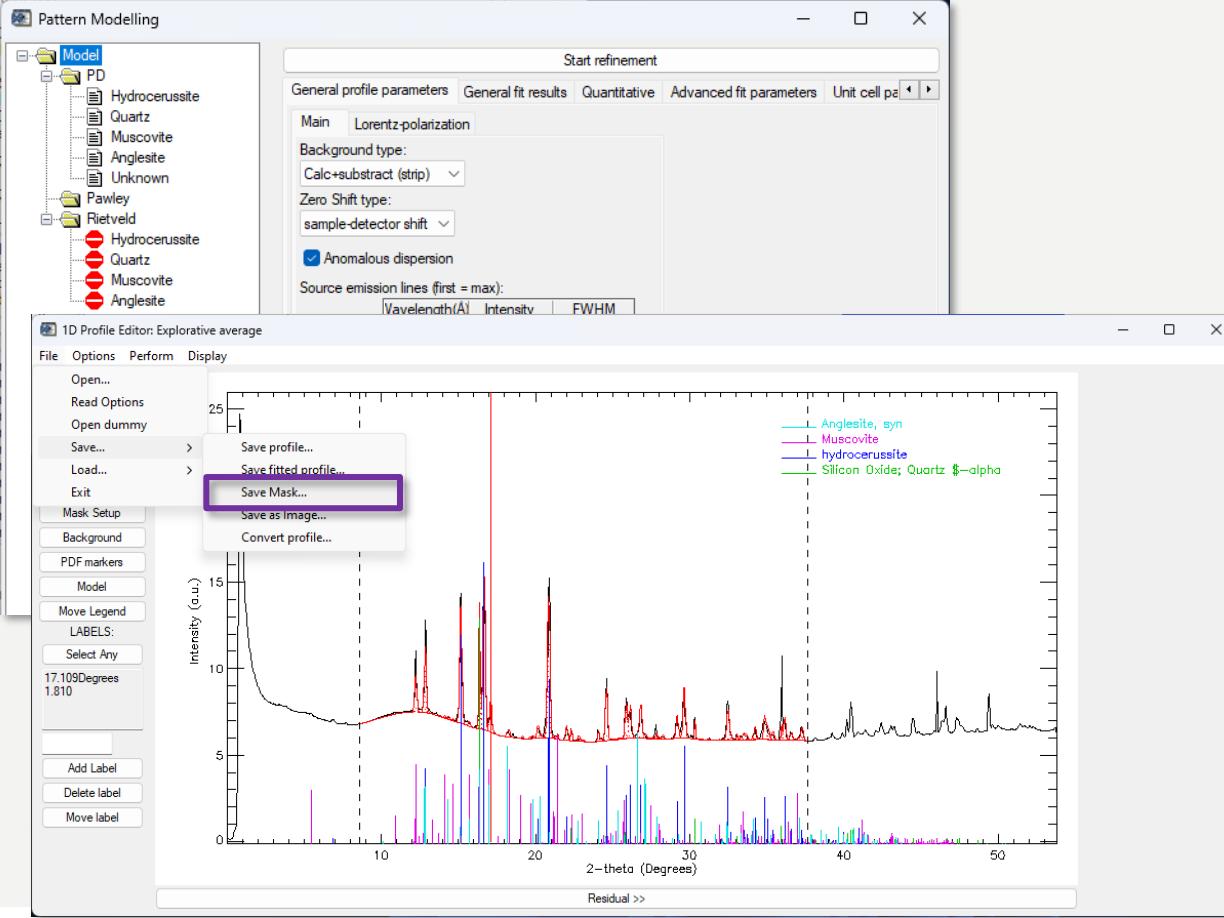
U	V	W	IG
0	0.00000	0.00000	0.00000

Note: We do not put the intensity to Global, since these values can strongly change for each signal depending on the hotspot intensity.

XRDUA 1D + Model

Unknown phase

1. Since the peaks selected here belong to the same phase, we want to set the Position to Global. I do not refine the individual FWHM → Deselect Refined for FWHM)
2. In the Initial tab, set isodeform to 1
 - Start refinement and check fit
 - Set Initial = Refined again to update the initial parameters
 - Set constraints on Position
 - Rerun fit to check for mistakes :-)



XRDUA 1D + Model

Finally ready with the model

- Restore the background
- Make sure only the relevant groups are included
- Save the model

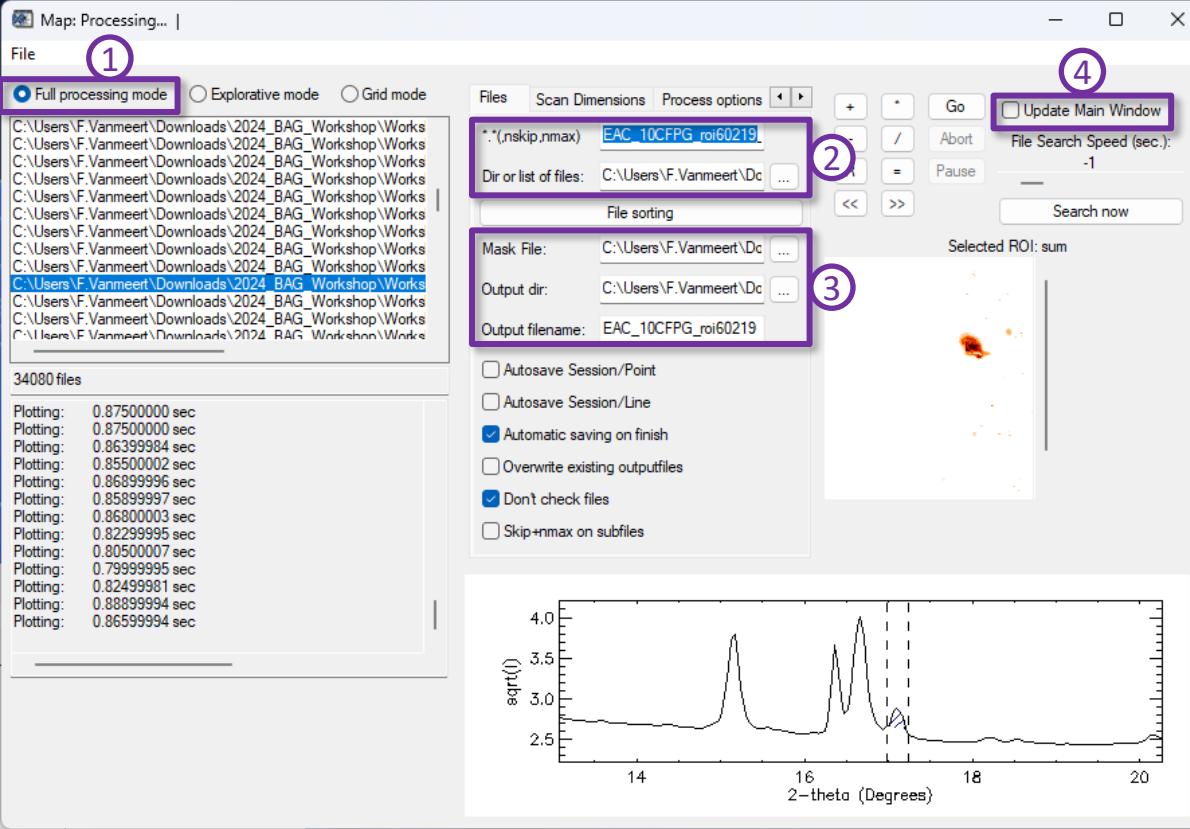
Tip: this is also a mask file with .msk extension. Do not confuse this with the mask file used in XRDUA BP.



5. Creating a Fit Model

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XRDUA BP

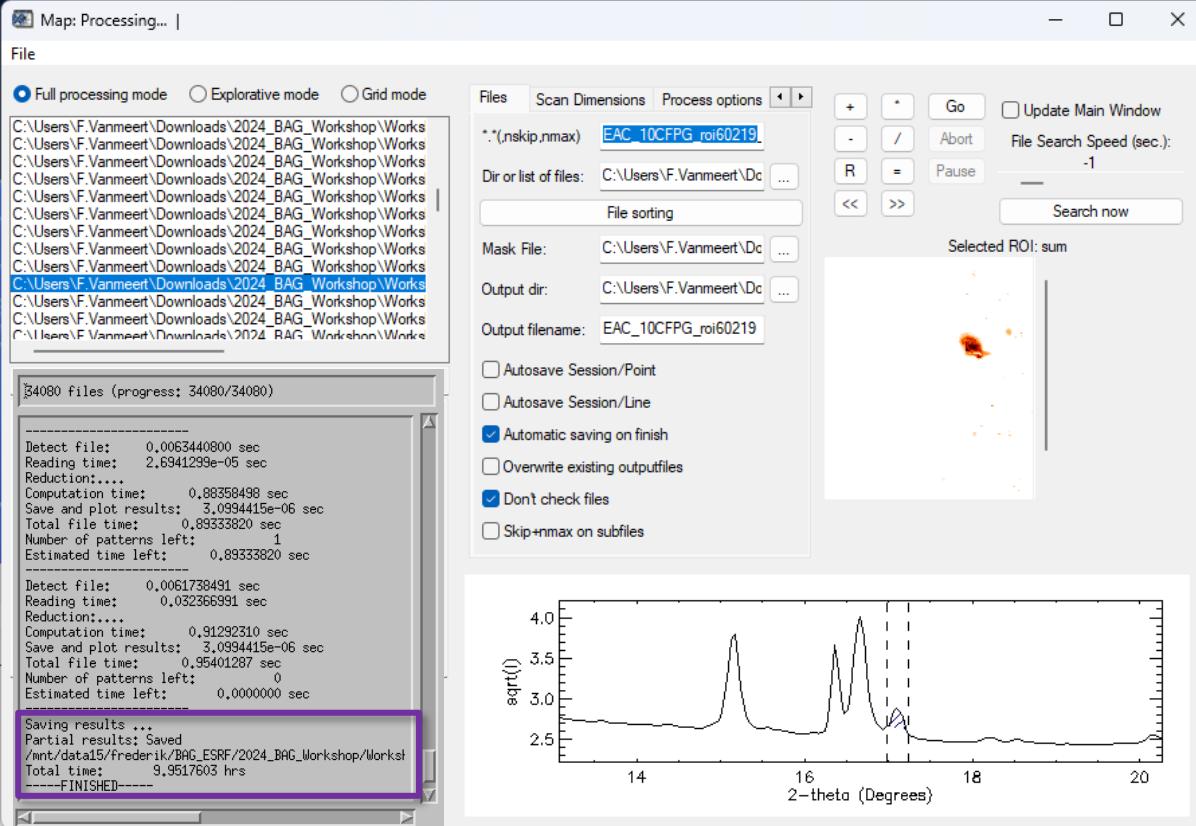
Full Processing with model

- Restore batch process (if it was closed): File -> Restore Session
- 1. Select Full processing mode
- 2. Change file to .tiff file generated by the Explorative mode batch process
- 3. Change Mask File to the fit model and change output directory and filename
- 4. Deselect Update Main Window
 - Deselect View progress (under Process options)
 - Press Go

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6. Batch processing of fit model

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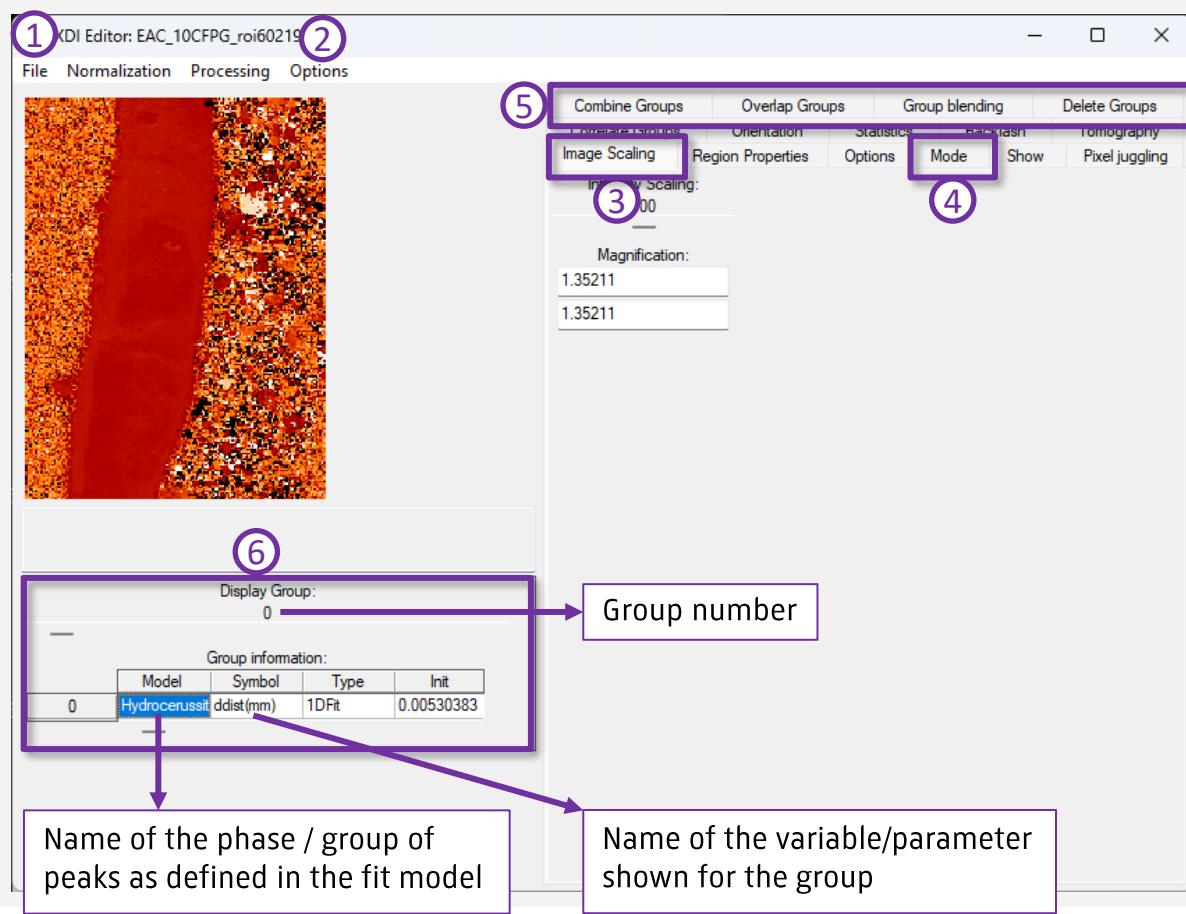
XRDUA BP

Full Processing with model

- Wait ... or do something else
(e.g., this fit took 10 h to finish)

Tip: the batch session in Full processing mode does not get saved automatically. Save it so that you can easily rerun it in case you need to make a change to the fit model.

6. Batch processing of fit model



XRDUA XDI

Some main options

1. Save/Convert/Export images
2. Change color
3. Image and intensity scaling
4. Various options, including a link to **XRDUA 1D**
5. Options to manipulate groups
6. Window to scroll through the results
 - Each variable that was refined in the fit is present as a group
 - Also, standard deviations, derived parameters, quality of fit metrics are saved as a group

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XRDUA XDI

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Parameters
SortOptions

Combine Groups Overlap Groups Group blending Delete Groups
Correlate Groups Orientation Statistics Backlash Tomography
Image Scaling Region Properties Options Mode Show Pixel juggling

Intensity Scaling:
40

Magnification:
2
2

①

XDI parameters

Charsize (%xsize) : 1.00000

Label-index : 0

Output nx : 4

1D plot markers :

Open formatted:

unformatted

Manual color table:

Color index for boarders : 0

Color index for labels : 255

HDF5 data :

DiffTomo/NXdata/sinogr.

HDF5 axis :

DiffTomo/NXdata/xaxis

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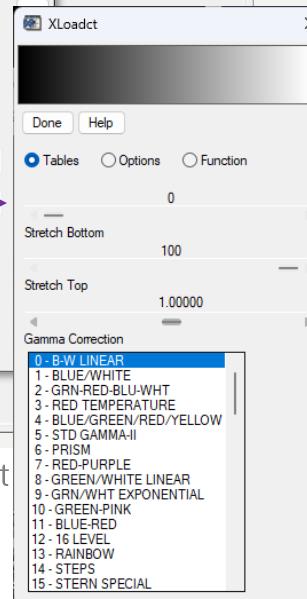
workshop

7. Results

XRDUA XDI

Looking at your results

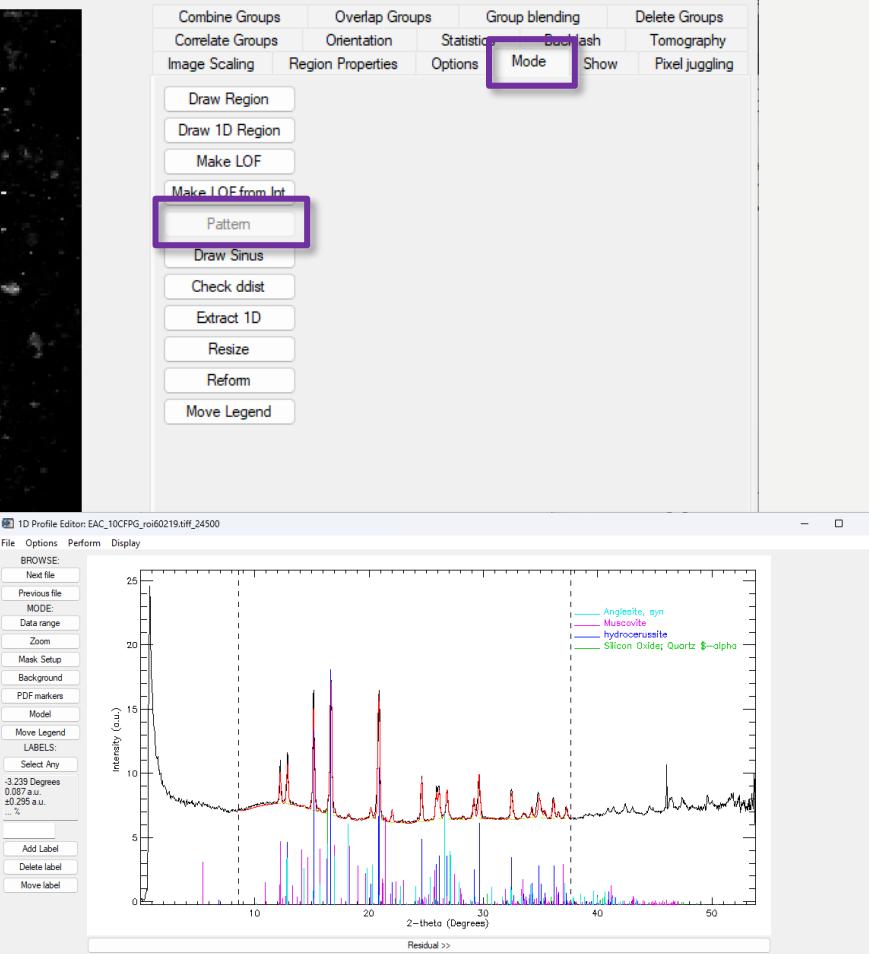
- Open .xdi file with **XRDUA XDI**
- 1. Change scaling (and intensity)
- 2. Option to change color
 - Go to Options → Parameters
 - Deselect Manual color table
 - Select color





POSITION=[83,0], COORD.=[0.00000mm,0.00000mm]
FILEPOS.[83,0], FILENR.=83
INT.=1.86639e-07

Display Group:		
Group information:		
Model	Symbol	Type
0	Hydrocerussit scaling	1DFit



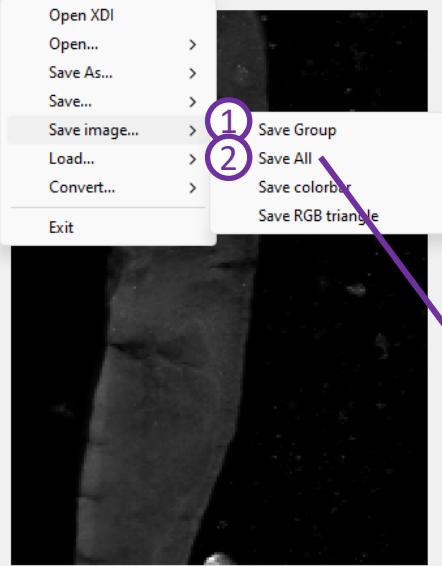
7. Results

XRDUA XDI

Verify results!

- Go to Mode and click Pattern
- Click on a pixel in **XRDUA XDI** to load the 1D profile in **XRDUA 1D**
- Verify if the model is working properly in this pixel
- Make changes to the model if necessary and rerun the fit
 - E.g., change initial values, change constraints, add other phases, ...

The model is constructed using only a small number of pixels. It is important to check if the model works well for the entire map!



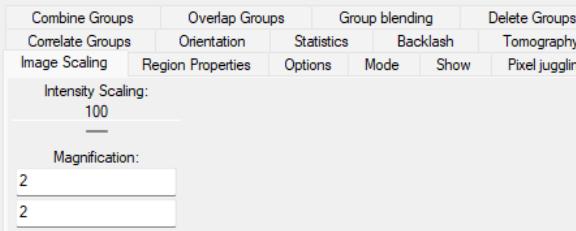
POSITION=[4,0], COORD.=[0.00000mm,0.00000mm]
FILEPOS=[4,0], FILENR.=4
INT.=9.35142e-10

Display Group:

1

Group information:

Model	Symbol	Type	Init
0	Hydrocerussit scaling	1DFit	8.70519e-09



XRDUA XDI

Exporting results

- Results are exported using the current (intensity) scaling

1. Single group

- Go to the group that you want to save
- Save Group

2. Multiple groups

- Write down all the group numbers that you want to save
- Save All
- Separate numbers of the group with a comma ,

Useful links and reads:

- [XRDUA Distribution Page](#)
Main XRDUA website with info, tutorials, and download link to latest version
- [XRDUA download | SourceForge.net](#)
Sourceforge page for XRDUA
- [NV5 | Customer Portal](#)
Portal to register and download IDL virtual machine needed to run XRDUA
- XRDUA Publication and general data processing strategy
<https://journals.iucr.org/paper?S1600576714008218>
- [American Mineralogist Crystal Structure Database](#)
Free crystal structure database with atomic information
- [Crystallography Open Database](#)
Free crystal structure database with atomic information
- [QualX – Software Ic](#)
Free Search-Match software